

TEST REPORT

Reference No...... : WTH26H03056177W003
Applicant..... : Shenzhen Jiayz photo industrial., Ltd
Address..... : A16 Building, Intelligent Terminal Industrial Park of Silicon Valley
Power, Guanlan, Longhua District, Shenzhen, China
Manufacturer..... : Shenzhen Jiayz photo industrial., Ltd
Address..... : A16 Building, Intelligent Terminal Industrial Park of Silicon Valley
Power, Guanlan, Longhua District, Shenzhen, China
Product Name..... : Dual-Channel Digital UHF Wireless Audio System for Filmmakers
Model No...... : K9 TX, K9 TX-JP
Test specification..... : Article 2 paragraph 1 item 1-12-2
Date of Receipt sample..... : 2026-03-09
Date of Test..... : 2026-03-13 to 2026-03-30 & 2026-05-12
Date of Issue..... : 2026-05-12
Test Report Form No...... : TRFITEM19-RF-001-V01
Test Result..... : Pass

Prepared By:

Waltek Testing Group HCT (Shenzhen) Co., Ltd.

Address: Building B, Tianji Industrial Park, 1/F. & 2/F. & 3/F., No.30-9, Laiyin Road, Xinseng Community,
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Contents

<u>1.</u>	<u>TEST STANDARDS AND REPORT VERSION</u>	<u>3</u>
1.1.	Test Standards	3
1.2.	Report version	3
<u>2.</u>	<u>TEST DESCRIPTION</u>	<u>4</u>
<u>3.</u>	<u>SUMMARY</u>	<u>5</u>
3.1.	Client Information	5
3.2.	Product Description	5
3.3.	EUT operation mode	5
3.4.	Test Frequency	6
3.5.	EUT configuration	6
3.6.	Modifications	6
<u>4.</u>	<u>TEST ENVIRONMENT</u>	<u>7</u>
4.1.	Address of the test laboratory	7
4.2.	Environmental conditions	7
4.3.	Statement of the measurement uncertainty	7
4.4.	Application of decision rule	8
4.5.	Equipments Used during the Test	9
<u>5.</u>	<u>TEST CONDITIONS AND RESULTS</u>	<u>10</u>
5.1.	RF shielding method	10
5.2.	Frequency Error	11
5.3.	Antenna Power and Antenna Power Tolerance	14
5.4.	Occupy Bandwidth (99%)	18
5.5.	Spurious emission intensity	22
5.6.	Adjacent channel Leakage Power	35
5.7.	Vibration Test	38
5.8.	Temperature and Damp heattest	40
<u>6.</u>	<u>TEST SETUP PHOTOS OF THE EUT</u>	<u>42</u>
<u>7.</u>	<u>EXTERNAL AND INTERNAL PHOTOS OF THE EUT</u>	<u>43</u>

1. Test standards and Report version

1.1. Test Standards

The tests were performed according to following standards:

Regulation: Appendix No.80 of MIC Notification No 88 and Article 2 paragraph 1 item 1-12-2: Specified radio microphone.

Test Method: Annex 80.

1.2. Report version

Revision No.	Date of issue	Description
Rev.00	2026-05-12	Original

2. Test description

Test Item	Result
RF shielding Method and Antenna Structure	PASS
Frequency Error	PASS
Vibration Test	PASS
Environmenta Test	PASS
Antenna Power	PASS
99% Occupied Bandwidth	PASS
Spurious Emissions Intensity	PASS
Adjacent Channel Leakage Power	PASS

3. Summary

3.1. Client Information

Applicant:	Shenzhen Jiayz photo industrial ., Ltd
Address:	A16 Building, Intelligent Terminal Industrial Park of Silicon Valley Power, Guanlan,Longhua District, Shenzhen, China
Manufacturer:	Shenzhen Jiayz photo industrial ., Ltd
Address:	A16 Building, Intelligent Terminal Industrial Park of Silicon Valley Power, Guanlan,Longhua District, Shenzhen, China

3.2. Product Description

Name of EUT:	Dual-Channel Digital UHF Wireless Audio System for Filmmakers
Trade Mark:	Saramonic
Model/Type reference:	K9 TX
Listed Model(s):	K9 TX-JP
Power supply:	DC 3V by battery or DC 5V from adapter
Battery Capacity:	/
Adapter information:	/
Software Version:	V2.53
Hardware Version:	V1.0
Note: The test data is gathered from a production sample, provided by the manufacturer. The model naming of others models listed in the report is different from main-test model K9 TX, but the circuit and the electronic construction do not change, declared by the manufacturer.	
RF Specification	
Frequency Range:	550-713MHz
Channel Spacing:	25KHz
Channel number:	6521
Modulation type:	GFSK
Antenna Type:	Whip Antenna
Antenna Gain:	2.0 dBi

3.3. EUT operation mode

The EUT has been tested under typical operating condition. The Applicant provides software to control the EUT for staying in continuous transmitting and receiving mode for testing.

3.4. Test Frequency

Test Channel	Channel No.	Frequency (MHz)
CH _L	01	550.000
-	02	550.025
-	⋮	⋮
CH _M	3261	631.500
-	⋮	⋮
-	6520	712.075
CH _H	6521	713.000

3.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

- supplied by the manufacturer
- supplied by the lab

○ AC/DC ADAPTOR	Manufacturer :	SHENZHEN JIYIN INDUSTRIAL CO.,LTD.
	Model No. :	JYSY005-0501000E
○ USB line	Length (m) :	0.6

3.6. Modifications

No modifications were implemented to meet testing criteria.

4. Test Environment

4.1. Address of the test laboratory

All measurement required was performed at Waltek Testing Group HCT (Shenzhen) Co., Ltd. At Building B, Tianji Industrial Park, 1/F. & 2/F. & 3/F., No.30-9, Laiyin Road, Xinsheng Community, Longgang Subdistrict, Longgang District, Shenzhen, Guangdong, China.

4.2. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

EUT supply power	RF module input power	Rated RF module power	Tolerance (%)
DC 3V	DC 3.3V	DC 3.3V	0
DC 2.7V	DC 3.3V	DC 3.3V	0
DC 3.3V	DC 3.3V	DC 3.3V	0
DC 5V	DC 3.3V	DC 3.3V	0
DC 4.5V	DC 3.3V	DC 3.3V	0
DC 5.5V	DC 3.3V	DC 3.3V	0
Conclusion: when the input voltage to EUT from the external source changes at 10%, the change of the input voltage to RF Module circuit of EUT is less 1%, another test item only need to test for normal condition.			
Other	Normal Temperature/Tnor:	23°C	
	Relative Humidity	57 %	
	Air Pressure	101 Kpa	

4.3. Statement of the measurement uncertainty

Parameter	Uncertainty
Frequency Error	70 Hz
Total RF power, conducted	0.51 dB
Spurious emissions, conducted	0.51 dB
DC and low frequency voltages	3%
Humidity	5%
Temperature	1°C

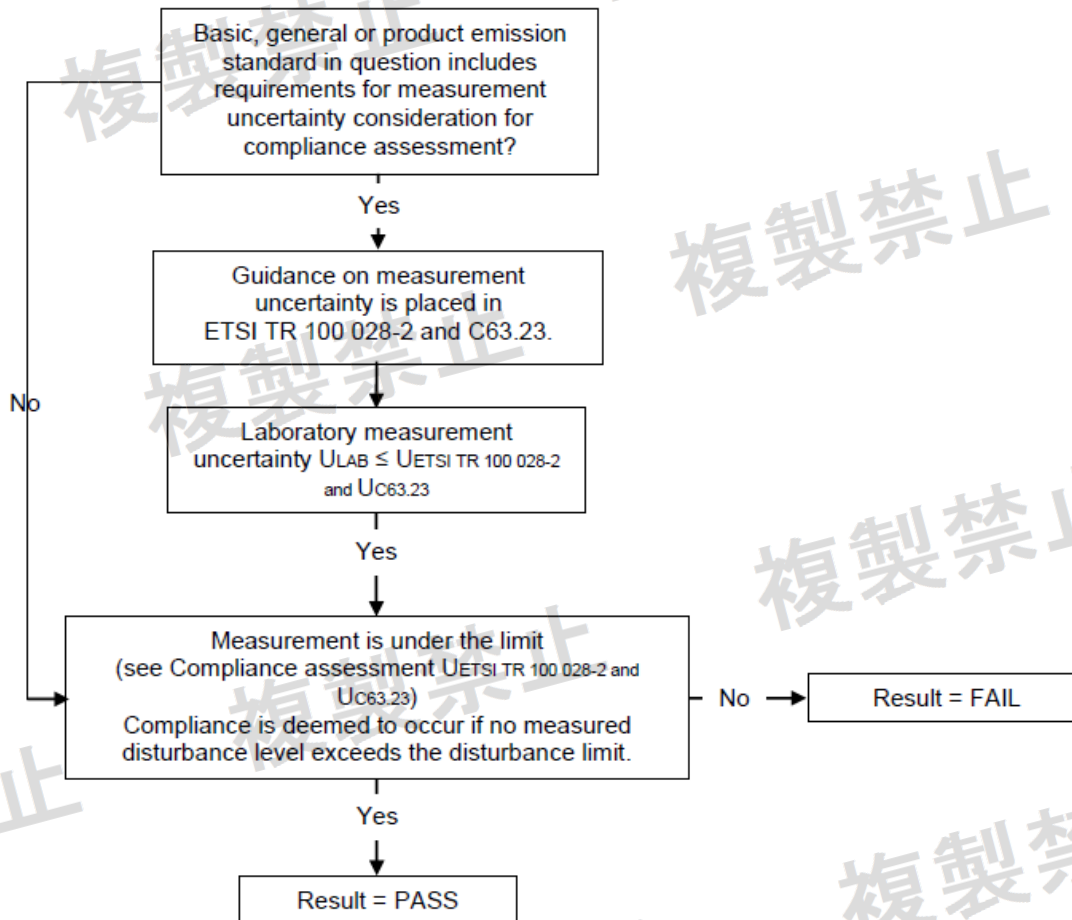
For the test methods, according to the present document, the measurement uncertainty figures shall be calculated in accordance with TR100028-1 [2] and shall correspond to an expansion factor (coverage factor) $K=1.96$ or $K=2$ (which provide confidence levels of respectively 95% and 95.5% in the case where the distributions characterizing the actual measurement uncertainties are normal).

4.4. Application of decision rule

Application of decision rule and statement of conformity is defined in document CNAS-GL015 Decision rule and measurement uncertainty.

As a general rule Pass/Fail decisions are based on simple acceptance rule and acceptance limits chosen based on simple acceptance ($w = 0$, $AL = TL$) except if a decision rule is governed by particular standard or guidance document.

Decision rule:



4.5. Equipments Used during the Test

Management number	Description	Manufacturer	Model	Serial Number	Cal Date	Due Date	Calibration Methods
WTHW1001A1-003	Spectrum Analyzer	Keysight	N9020A	/	2025-12-10	2026-12-09	JJF 1396-2013
WTHW1003A1-001	Power Meter	DARE!!	RPR3006W	/	2025-12-10	2026-12-09	JJF 1757-2019
WTHW1002A1-001	Vector Signal Generator	Agilent	N5182A	MY47071034	2026-01-14	2027-01-13	JJF 1931-2021
WTHP1275A1-001	Environmental Box	T-Machine	KTM-THC515	T1075	2025-12-01	2026-11-30	JJF 1101-2019
WTHP1201A1-002	Vibration	DONGLING	LT060L	/	2025-12-01	2026-11-30	JJG 948-2018
WTHW1006A1-001	Attenuator	/	ZN2PD-63+S	/	2025-12-10	2026-12-09	JJF 2092-2024
Software List							
Description		Manufacturer		Model		Version	
Test Software		Pomis		PTS2450		2.0.0.1#	
#Remark: indicates software version used in the compliance certification testing Calibration laboratory: CCIC (Shenzhen) Metrology & Testing Service Co.,Ltd Calibration laboratory address: ShengHui Hongxing Chuangzhi Square, Tongren Road, Tianliao Community, Yutang Street, Guangming District, Shenzhen Calibrated by:Jinhui Liu Calibration Methods: Calibration conducted in foreign countries, which is equivalent to calibration conducted by the NICT or a designated calibration agency under Article 102-18-1 of the Radio Act							

5. Test conditions and Results

5.1. RF shielding method

Rf shielding method: The enclosure is sealed by Special screws, it can not be easily open. Otherwise, the device will be damaged.



Antenna structure: The radio equipment has not equipped with a feeder and grounding device.

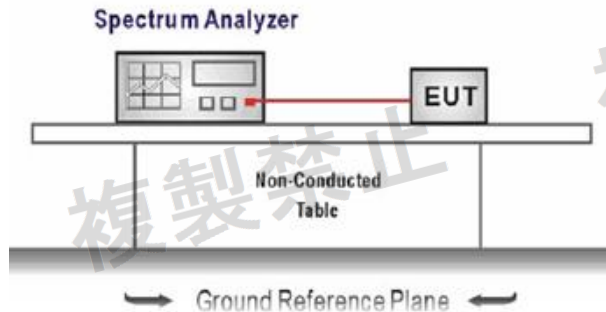


5.2. Frequency Error

LIMIT

 $\pm 20\text{ppm}$

TEST CONFIGURATION



TEST CONDITION

Without modulation, continuously transmitting

SPECTRUM SET:

Test Frequency= test channel,

RBW=VBW=10KHz, Span=1MHz, Sweep time=Auto, Detector mode=Positive peak

TEST RESULTS

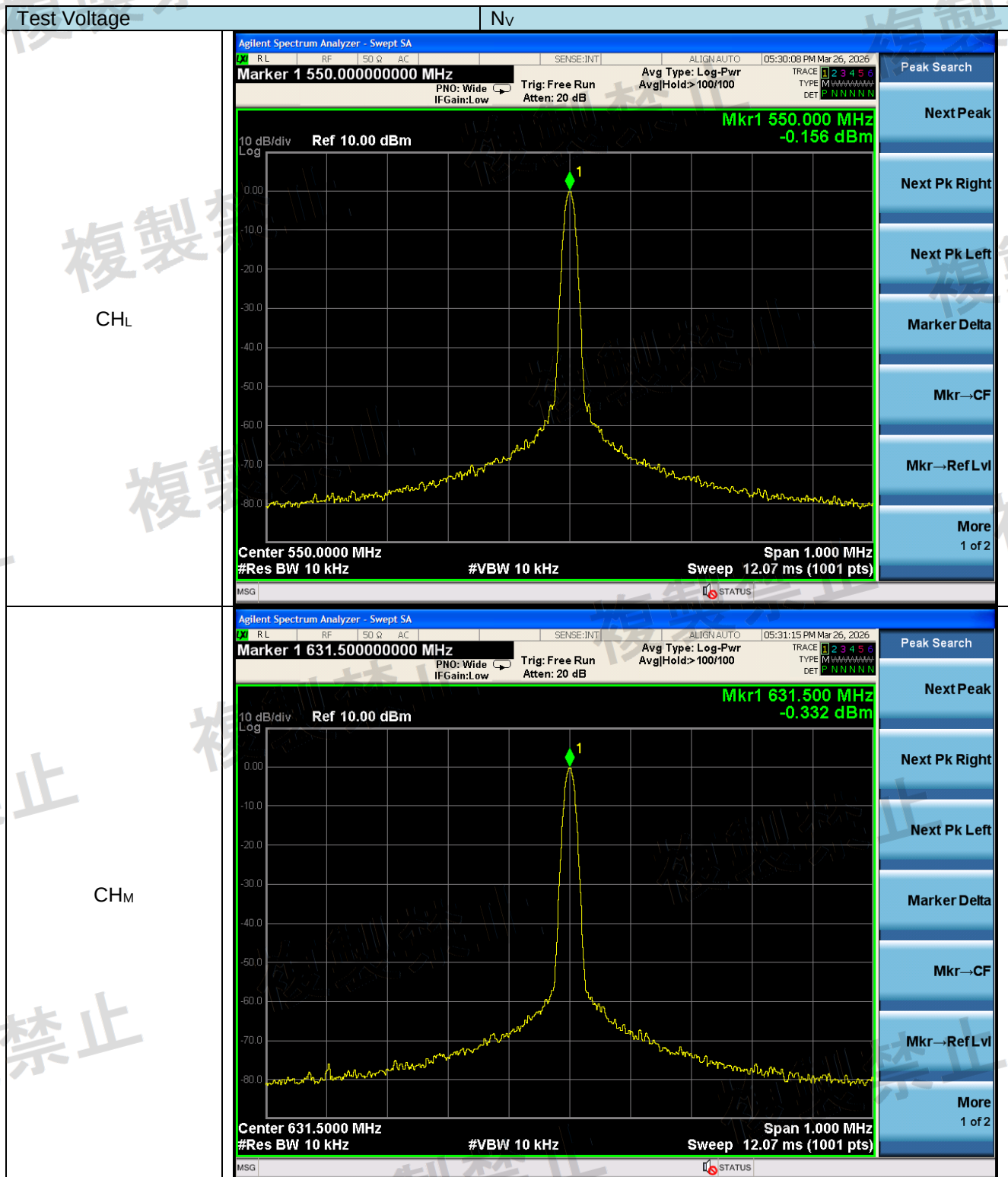
☒ Passed

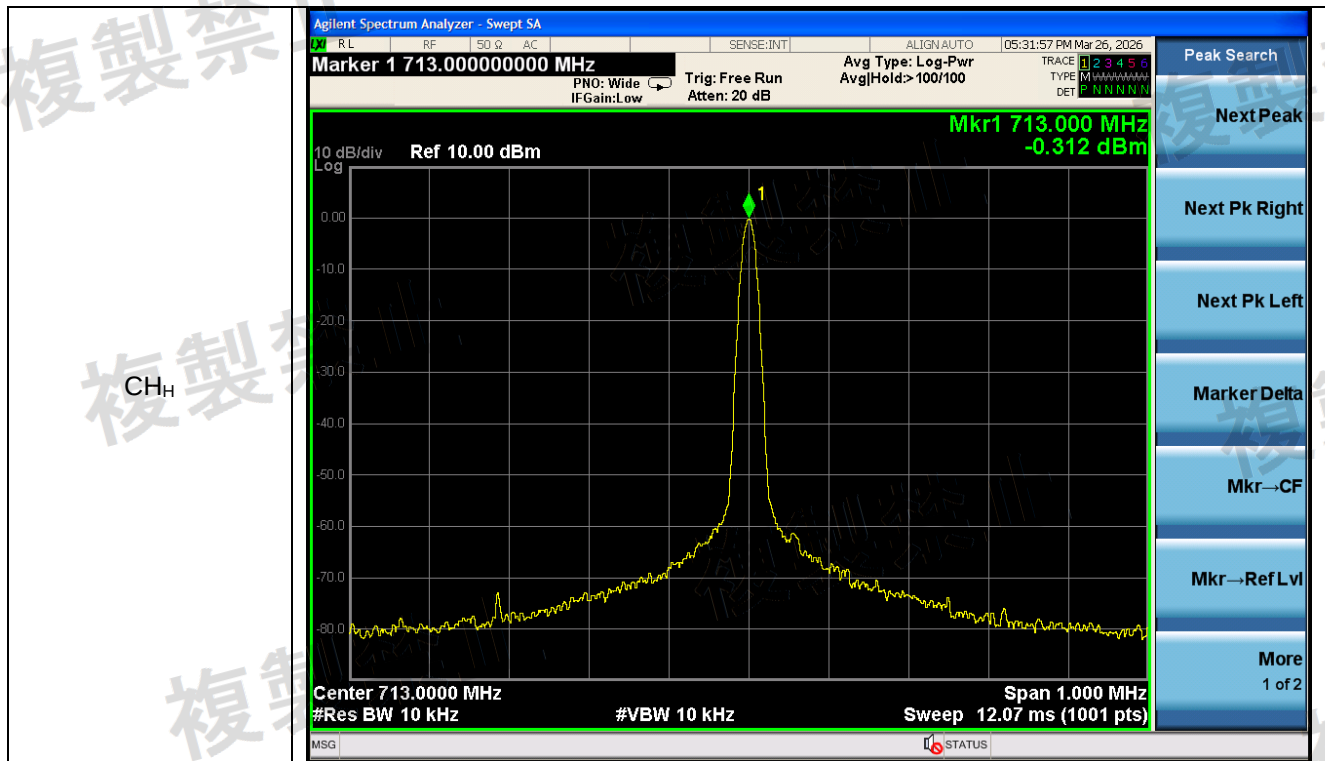
 ☐ Not Applicable

Please refer to the below test data:

Test voltage	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
N _v	CH _L	550	550.00	0.00	± 20.00	Pass
	CH _M	631.5	631.50	0.00		
	CH _H	713	713.00	0.00		

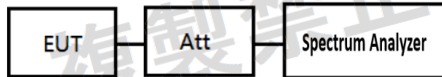
Test plot as follows:





5.3. Antenna Power and Antenna Power Tolerance**LIMIT**

Frequency band	Antenna Power Limit	Antenna Power Tolerance Limit
470~714 MHz	50mW or less	+20%,-50%
1240~1260 MHz	50mW or less	+50%,-50%

TEST CONFIGURATION

TEST CONDITION
Without modulation

TEST RESULTS

☒ Passed ☐ Not Applicable

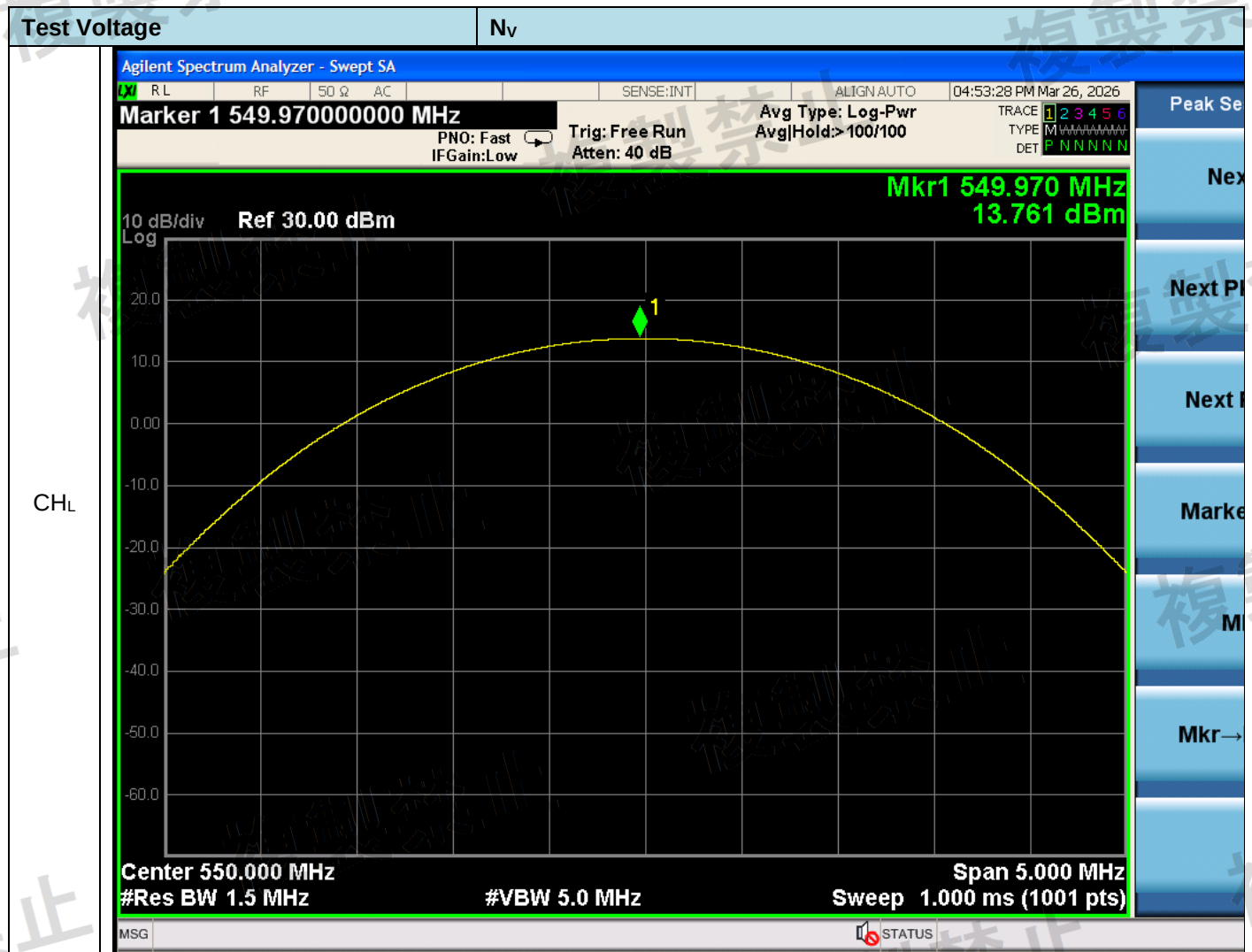
Please refer to the below test data:

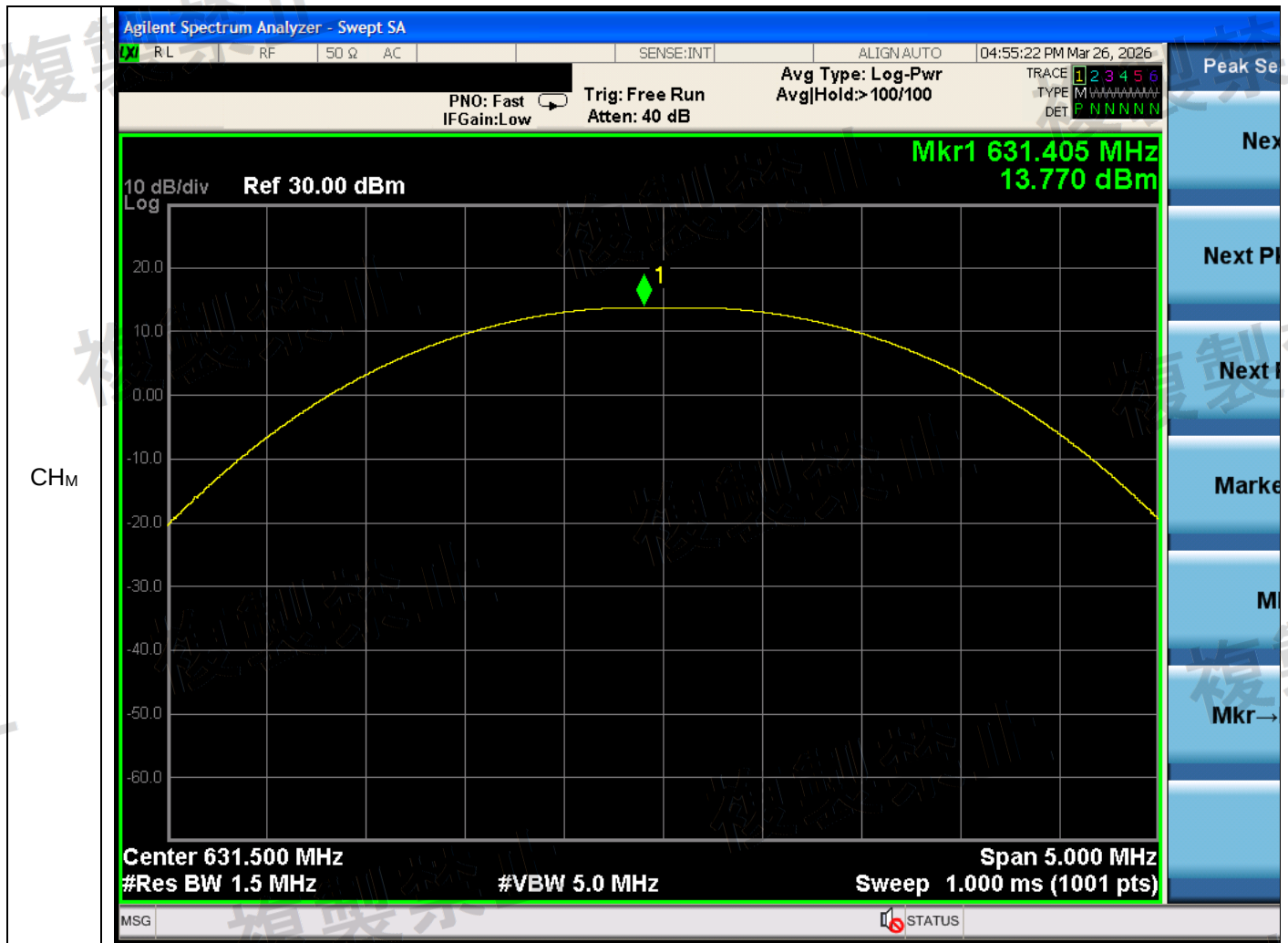
Test voltage	Test channel	Frequency (MHz)	Antenna power (dBm)	Antenna power (mW)	Limit (mW)	Declared Power (mW)	Tolerance (%)	Limit (%)	Result
N _v	CH _L	550	13.761	23.77	50	25	-4.92	-50~+20	Pass
	CH _M	631.5	13.770	23.82		25	-26.60		
	CH _H	713	11.826	15.23		25	-39.08		

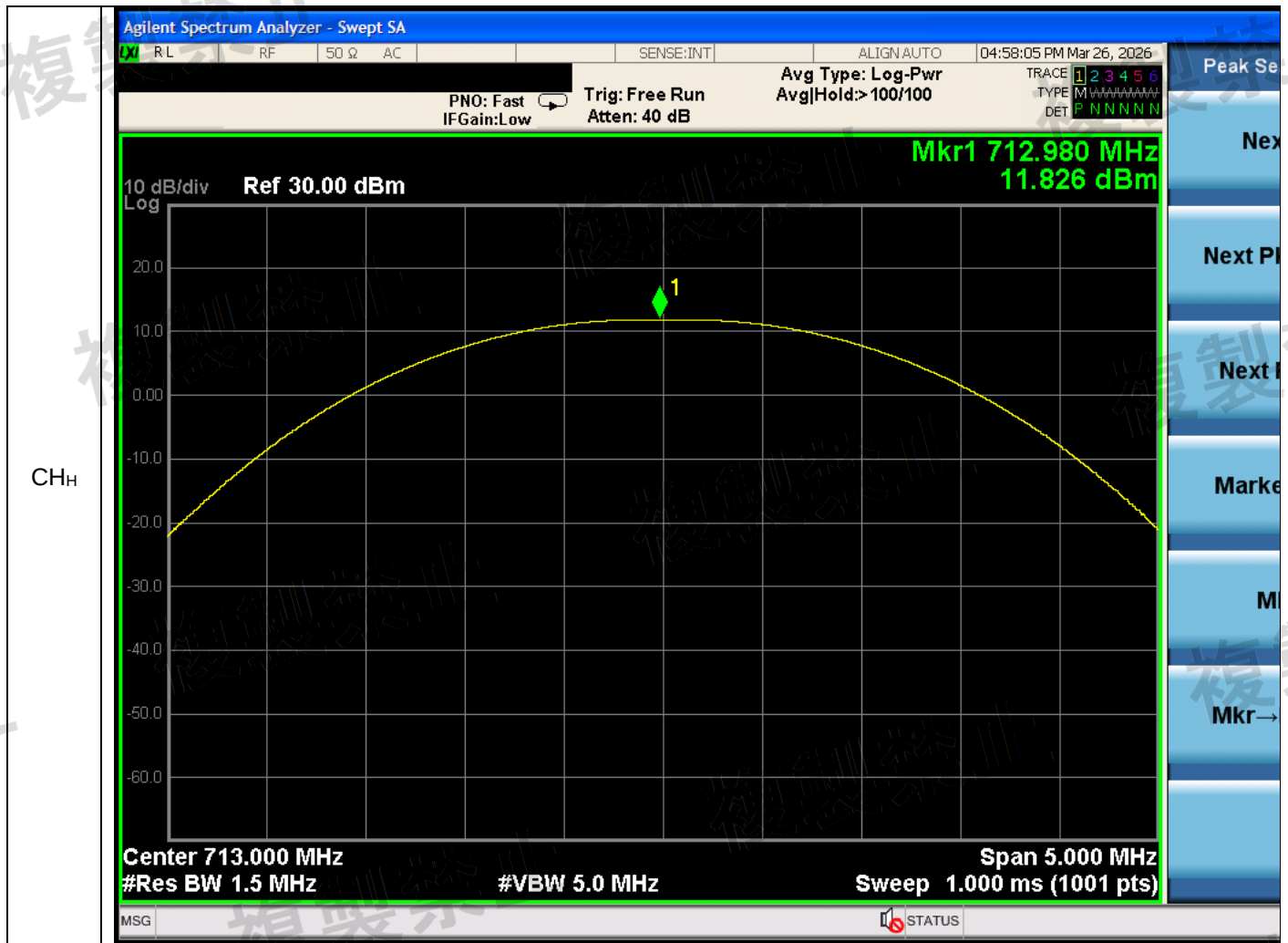
Note:

1) Tolerance = (Antenna power – Rated power) / Rated power *100%

Test plot as follows:





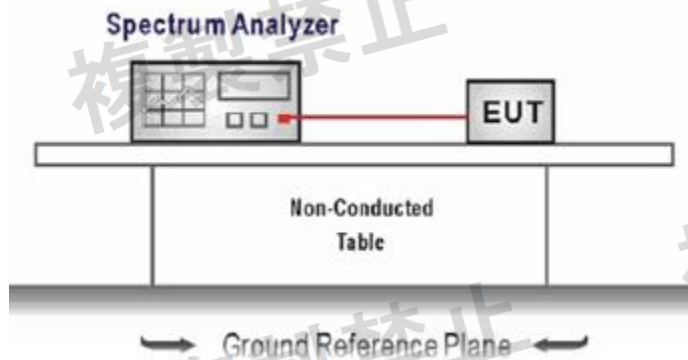


5.4. Occupy Bandwidth (99%)

LIMIT

Frequency band	Limit
470~714 MHz	$\leq 288\text{kHz}$
1240~1260 MHz	$> 288\text{kHz}$ and $\leq 600\text{kHz}$

TEST CONFIGURATION



TEST CONDITION

Test diffusion code and modulate with standard coding test signal

SPECTRUM SET:

Test Frequency: test channel,
RBW=5KHz, VBW=5KHz, Span=600MHz, Sweep time=Auto, Detector mode=RMS

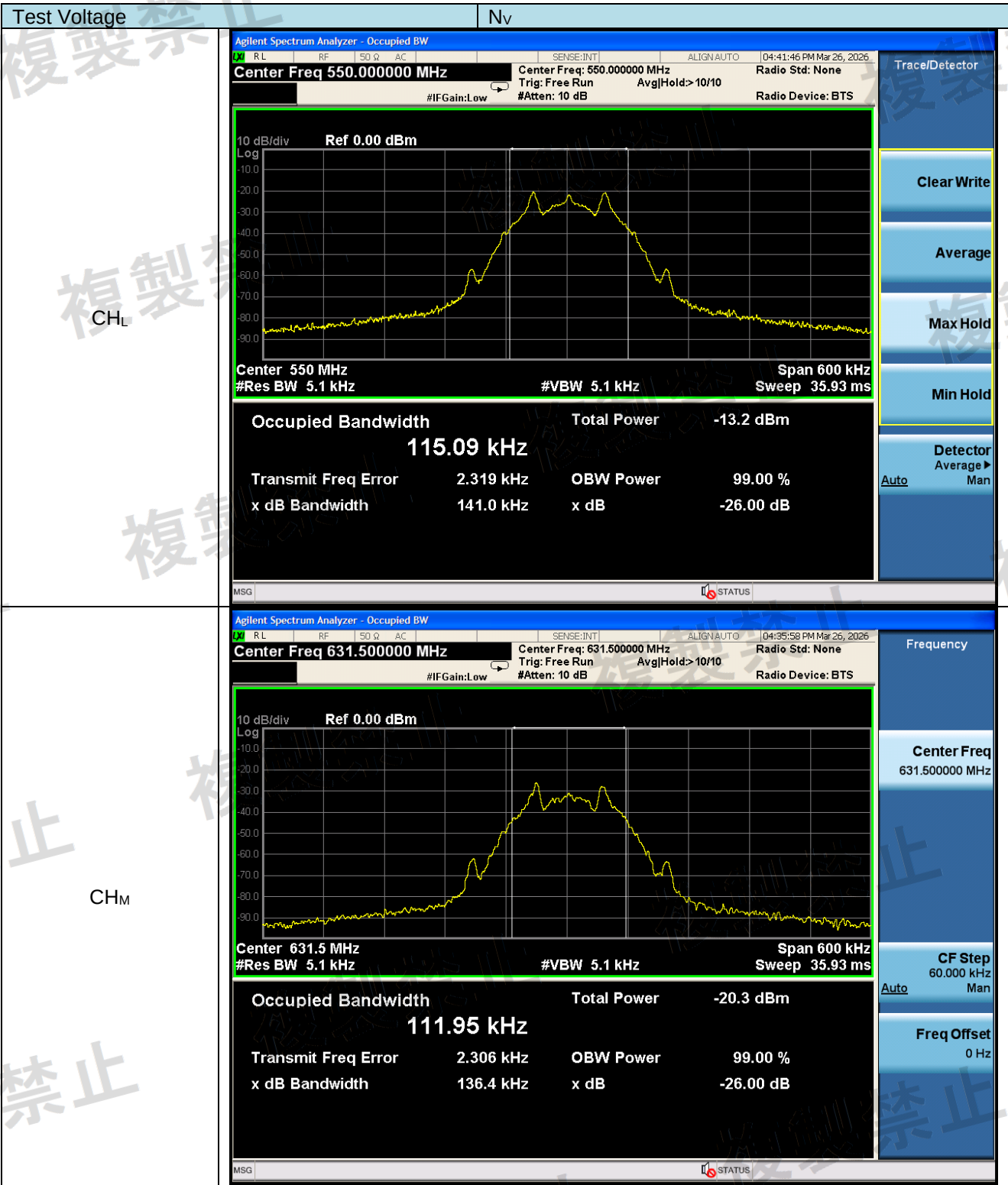
TEST RESULTS

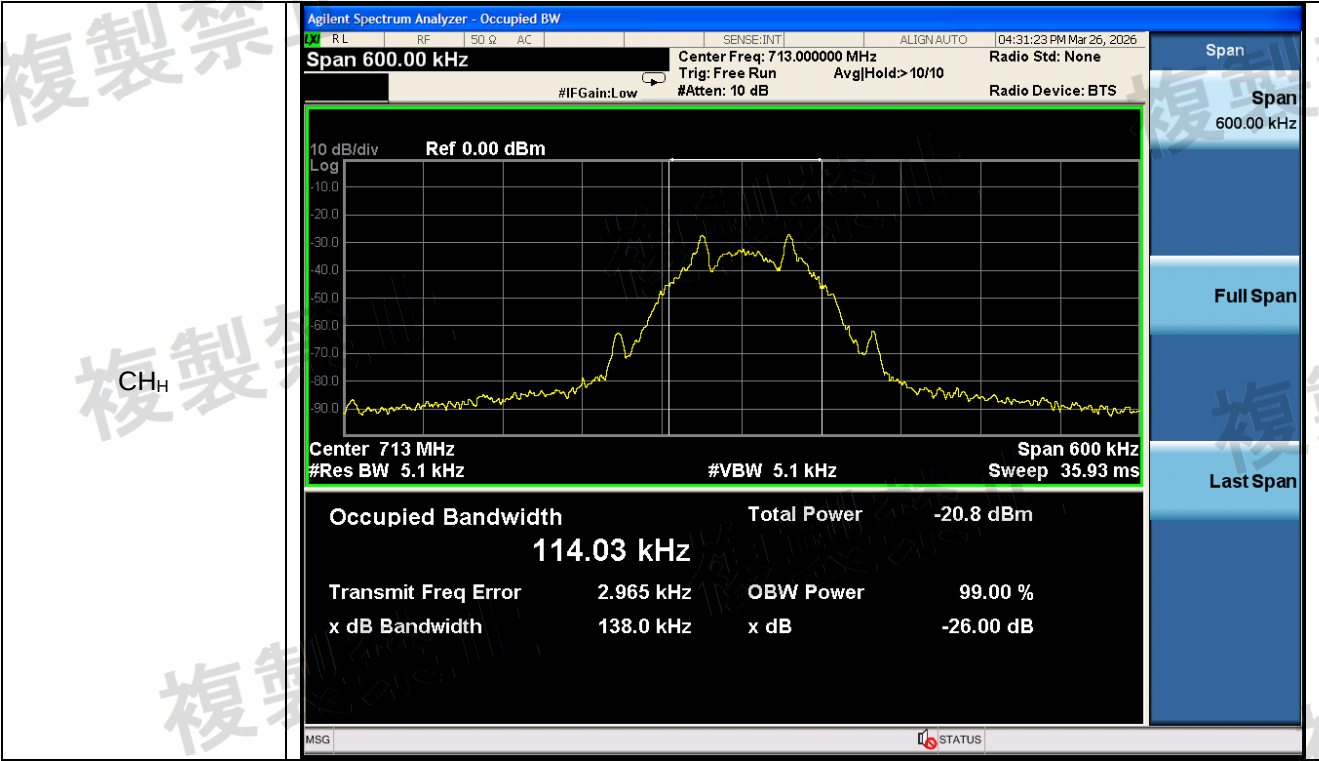
☒ Passed

☐ Not Applicable

Please refer to the below test data:

Test voltage	Test channel	99% occupy bandwidth (KHz)	Limit (KHz)	Result
N _v	CH _L	115.09	≤288	Pass
	CH _M	111.95		
	CH _H	114.03		



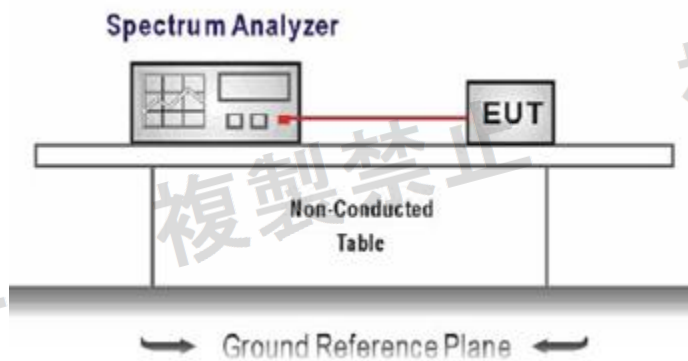


5.5. Spurious emission intensity

LIMIT

Frequency Range	Limit
9~150kHz	$\leq 2.5\mu\text{W}/1\text{kHz}$ (-26dBm)
150k~30MHz	$\leq 2.5\mu\text{W}/10\text{kHz}$ (-26dBm)
30~470MHz	$\leq 2.5\mu\text{W}/100\text{kHz}$ (-26dBm)
470~710MHz	$\leq 4\text{nW}/100\text{kHz}$ (-54dBm), (Cf $\pm 1\text{MHz}$: $2.5\mu\text{W}/100\text{kHz}$)
710~1000MHz	$\leq 2.5\mu\text{W}/100\text{kHz}$ (-26dBm)
1~4GHz	$\leq 2.5\mu\text{W}/\text{MHz}$ (-26dBm)

TEST CONFIGURATION



TEST CONDITION

Test diffusion code and modulate with standard coding test signal

SPECTRUM SET:

Test Frequency: test channel,

9~150kHz: RBW= 1kHz, VBW=3kHz;

150k~30MHz: RBW= 10kHz, VBW=30kHz;

30MHz~1GHz: RBW= 100kHz, VBW=300kHz

1~4GHz: RBW= 1MHz, VBW=3MHz

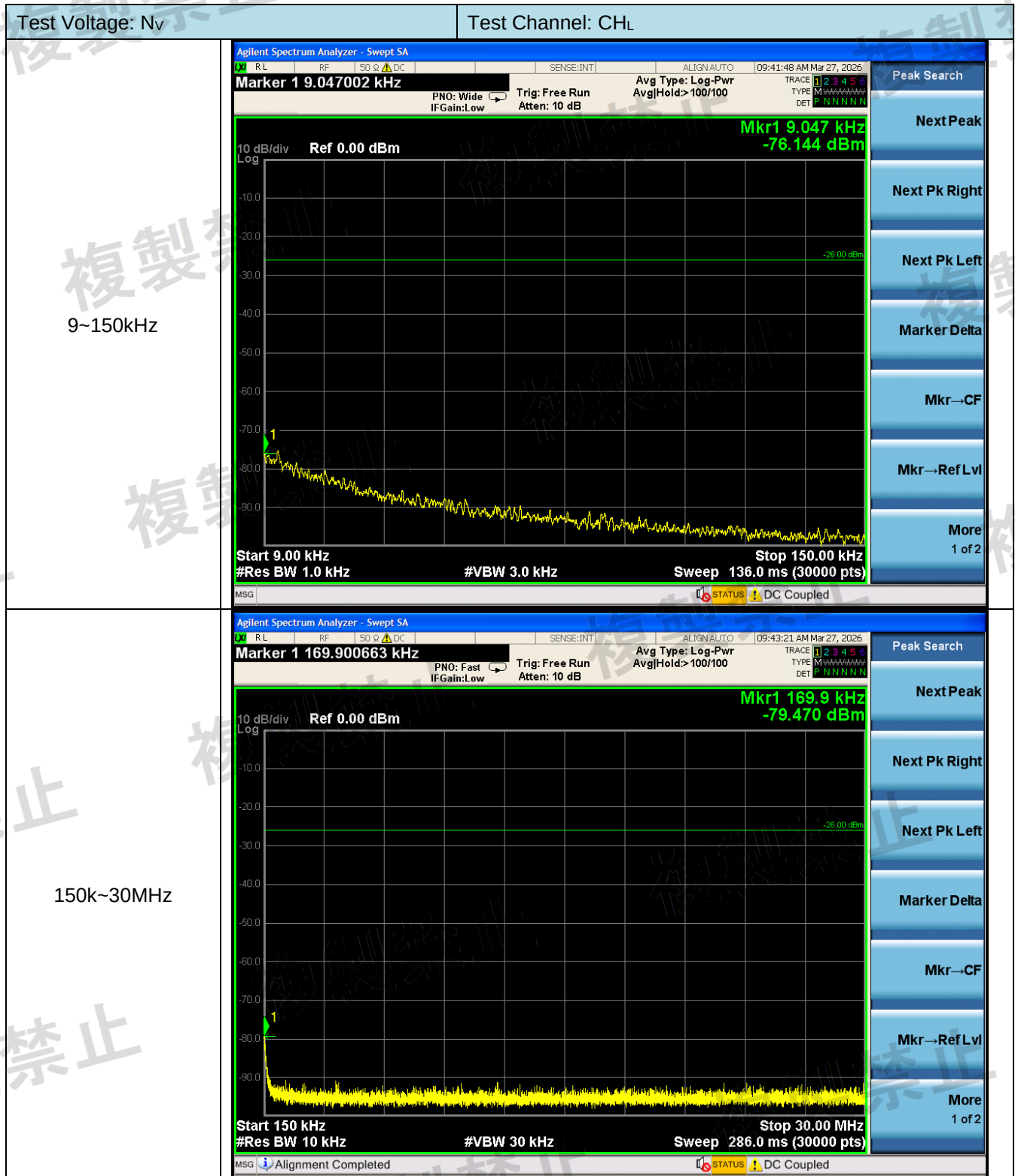
Sweep time=Auto, Detector mode=Positive peak

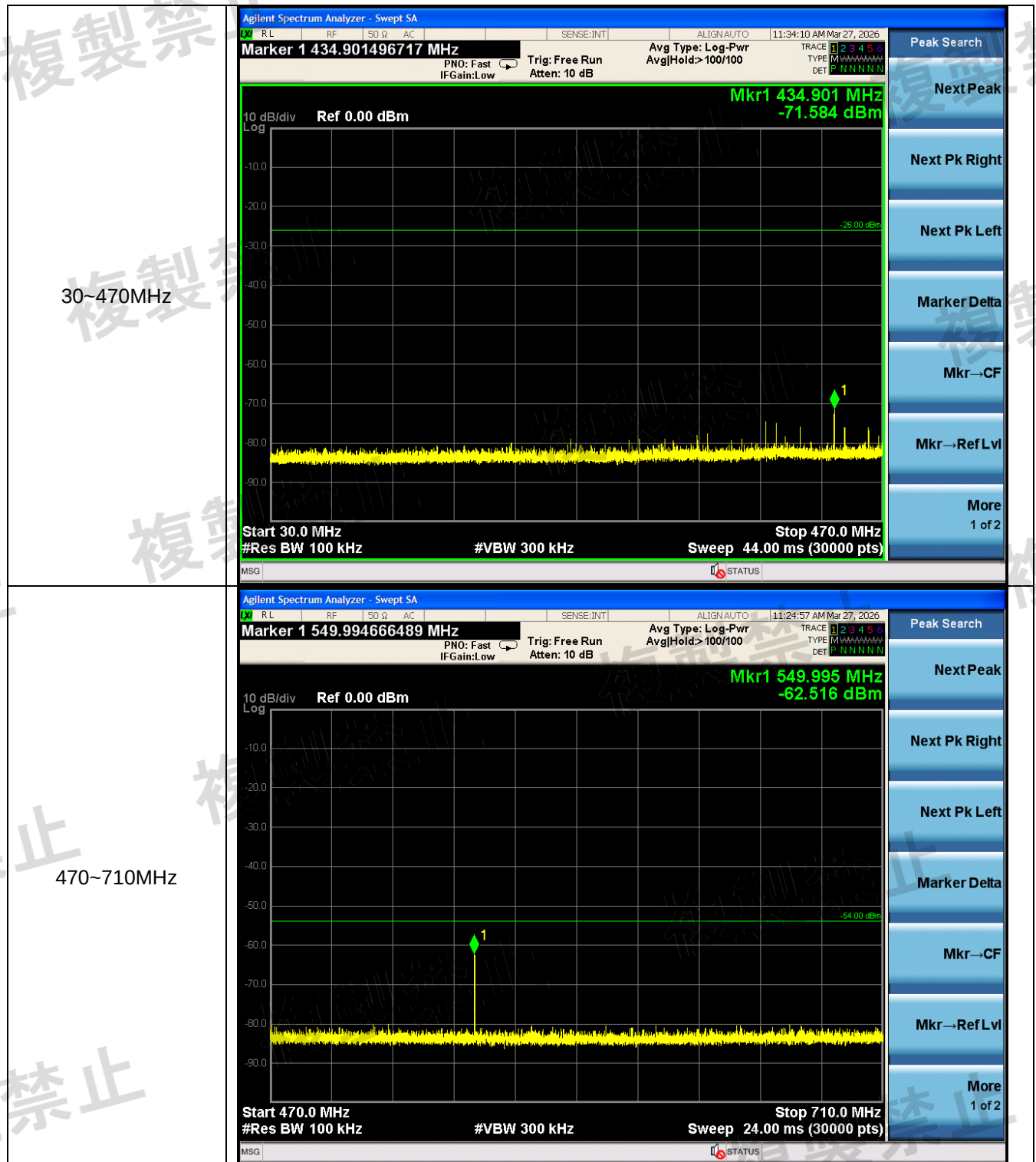
TEST RESULTS

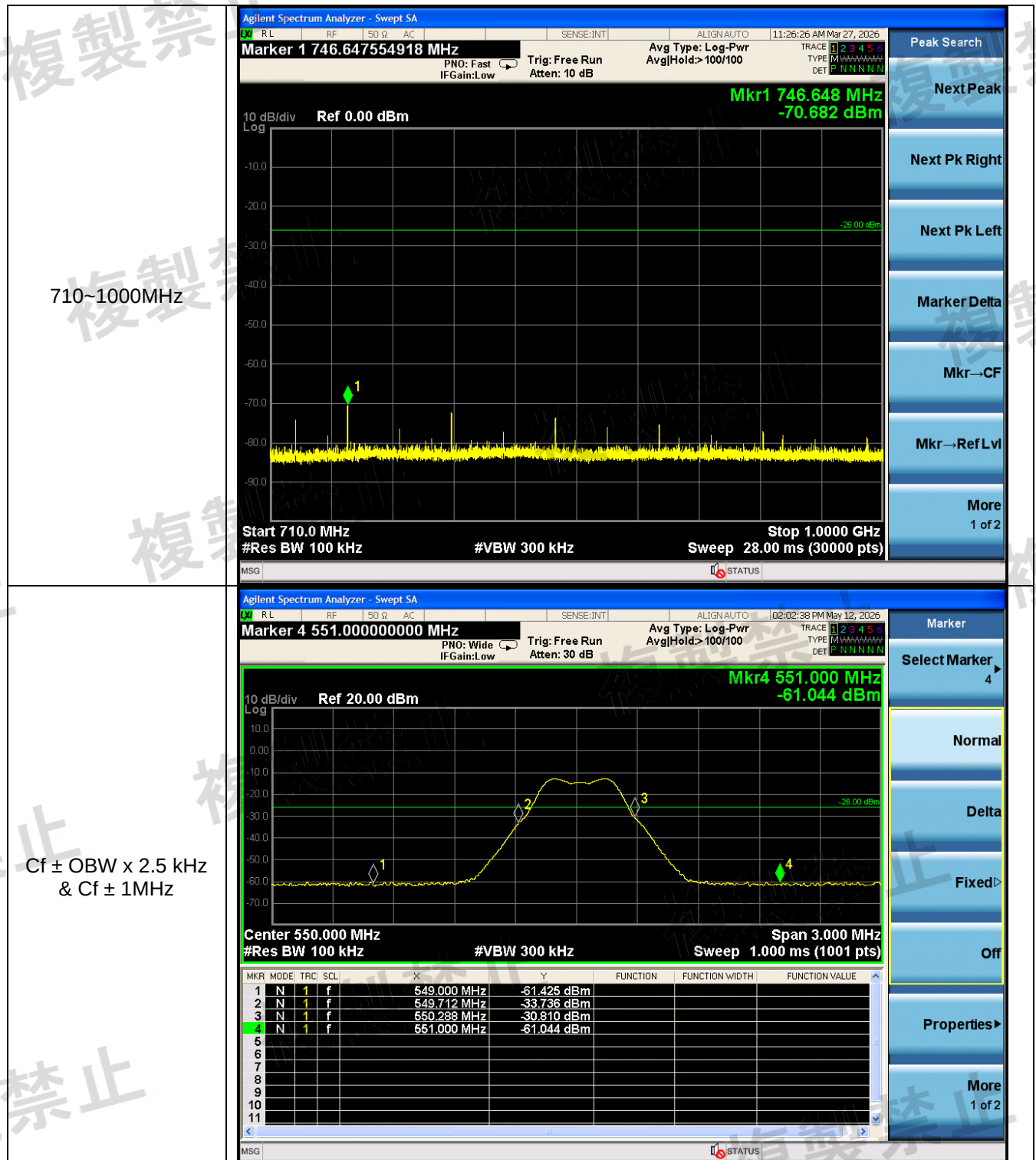
☒ Passed

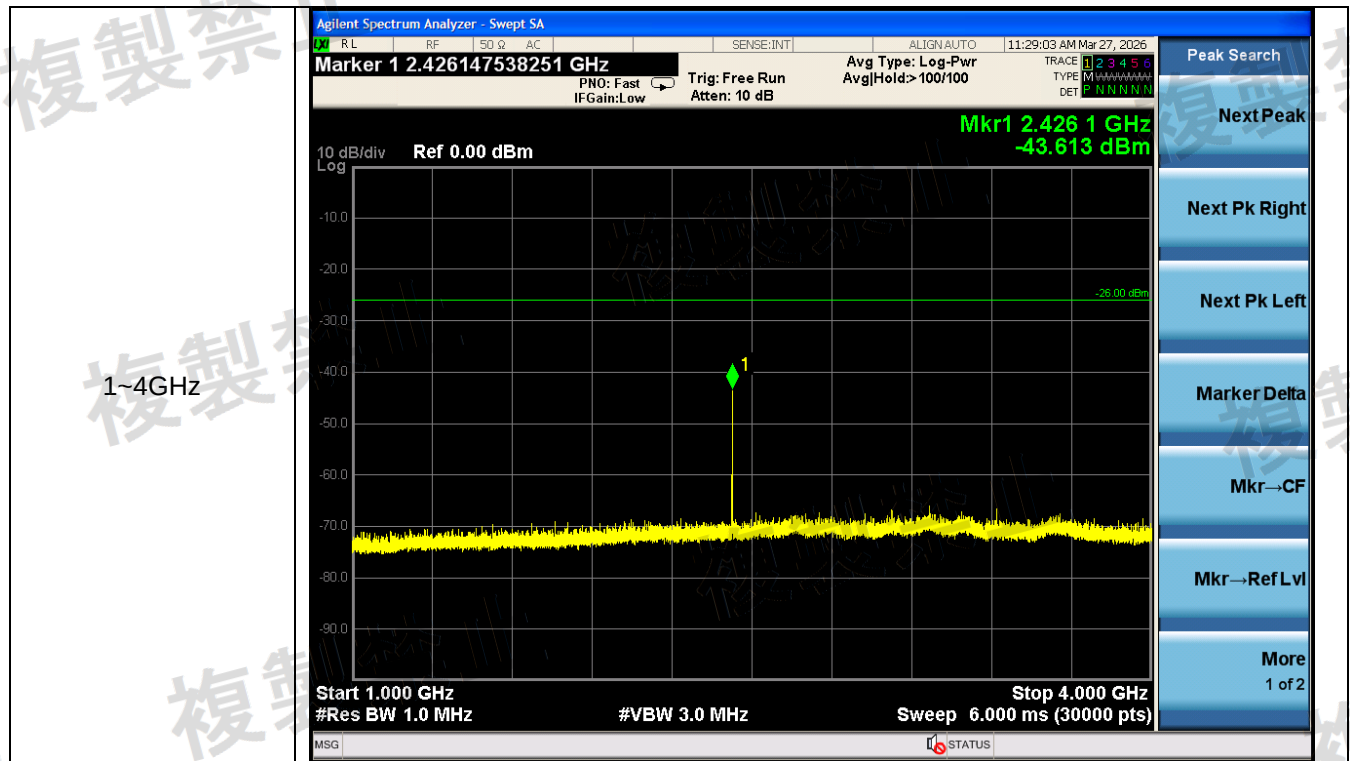
☐ Not Applicable

Please refer to the below test data:

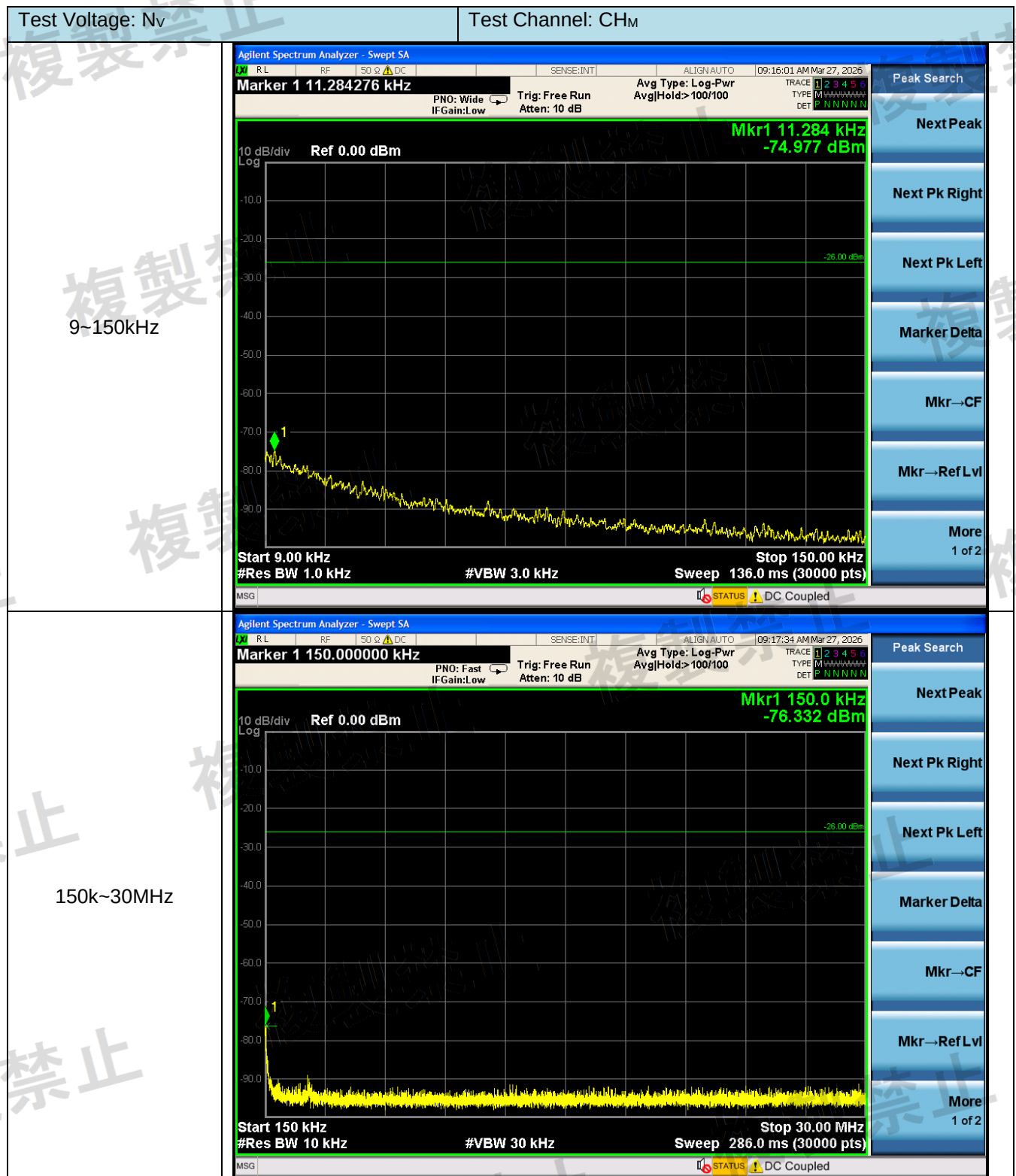


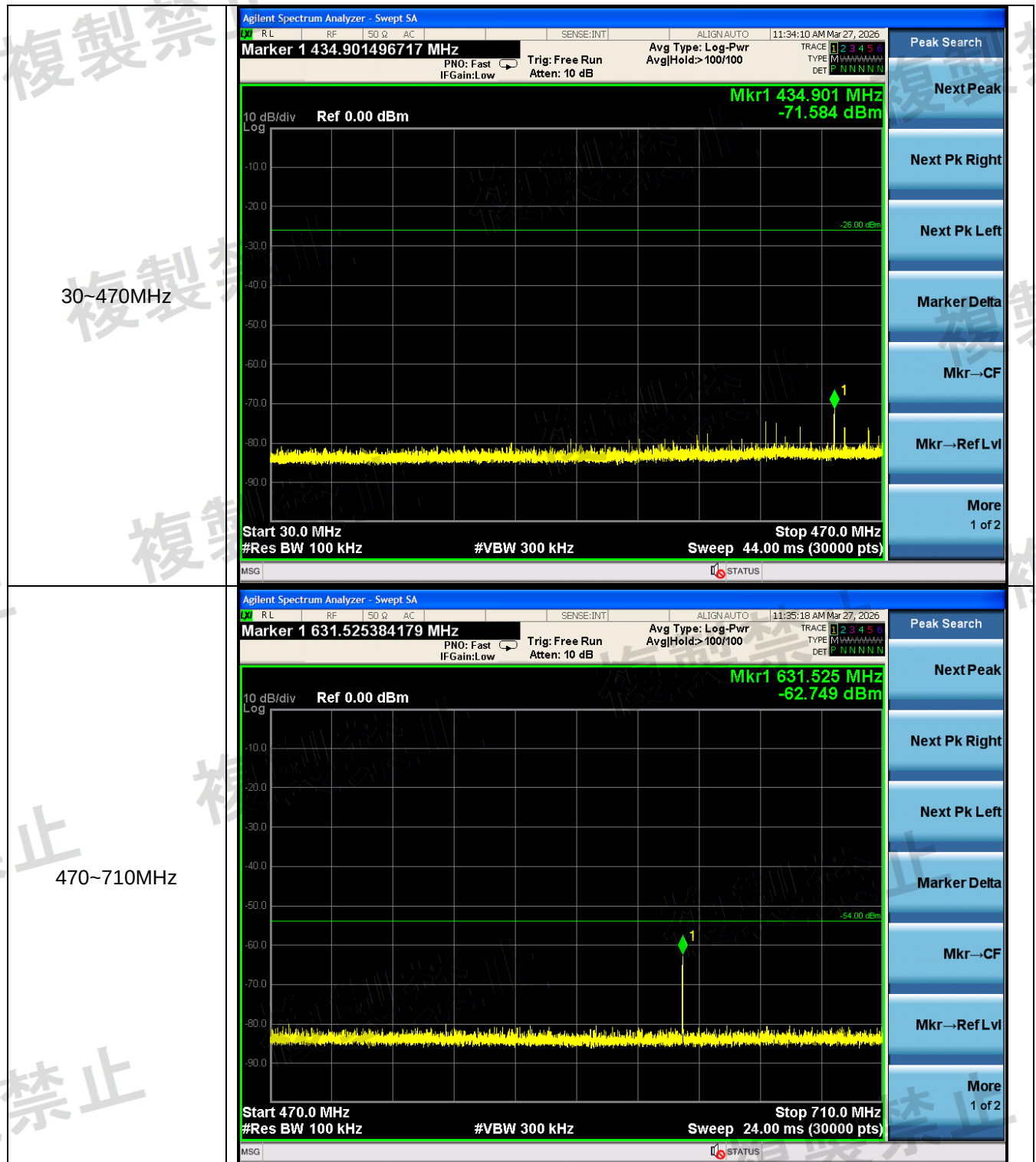


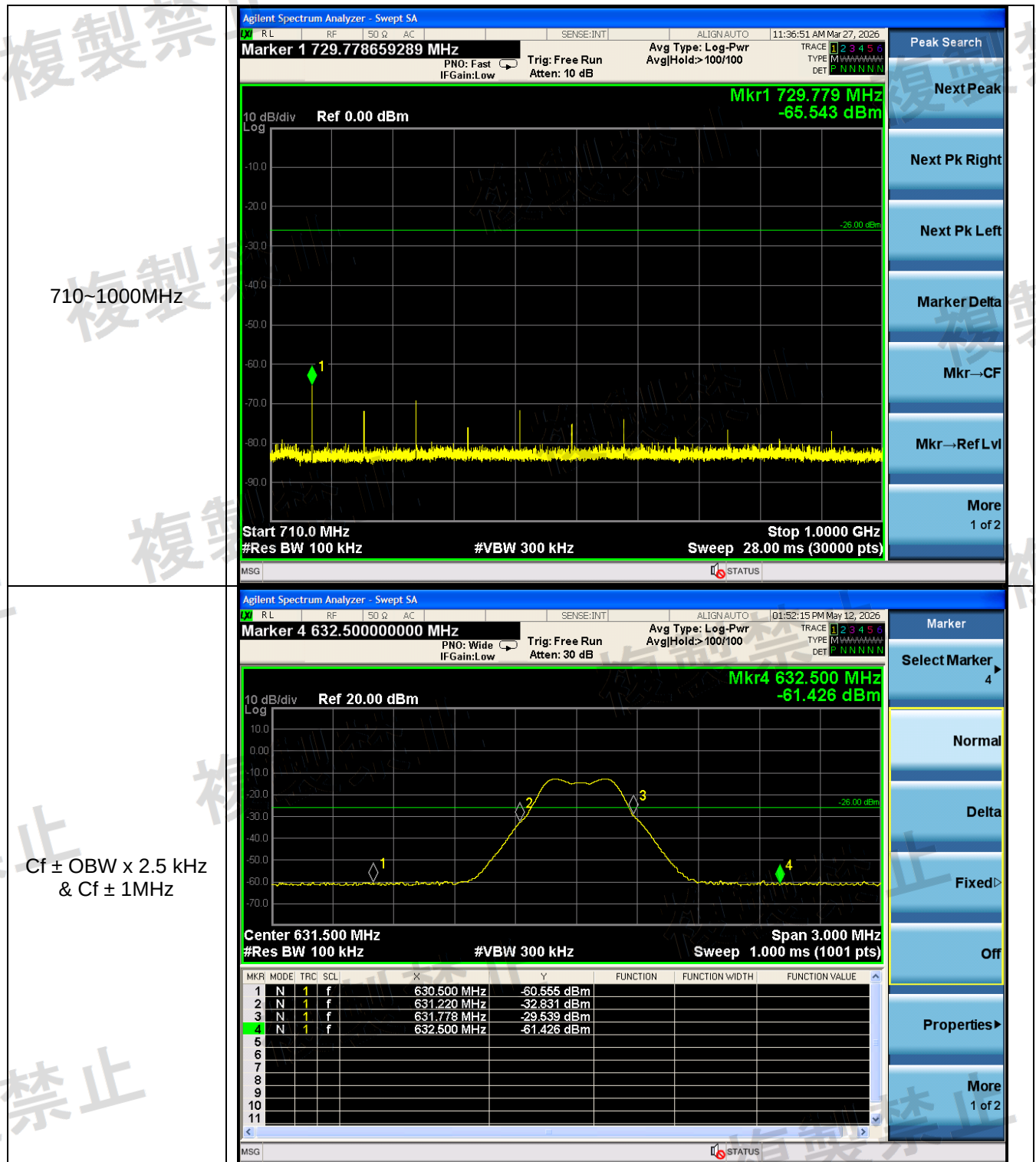


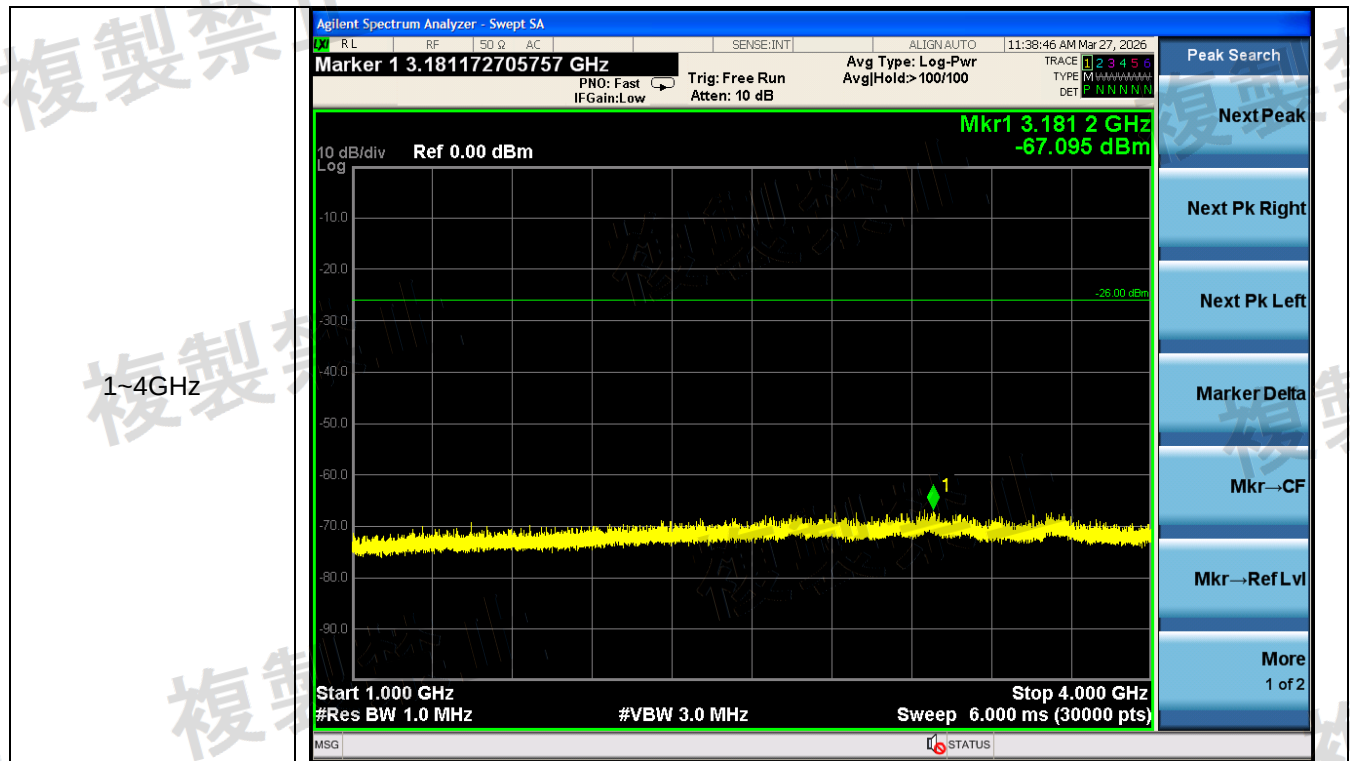


Test voltage	Test Channel	Frequency Range	Maximum frequency (MHz)	Measurement Level	Measurement Level	Limit	Result
N _v	CH _L	9~150kHz	0.009047	-76.144 dBm/1kHz	0.00002μW/1kHz	≤2.5μW/1kHz (-26dBm)	Pass
		150k~30MHz	0.1699	-79.47 dBm/10kHz	0.00001μW/10kHz	≤2.5μW/10kHz (-26dBm)	
		30~470MHz	434.901	-71.584 dBm/100kHz	0.00007μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		470~710MHz	549.995	-62.516 dBm/100kHz	0.6nW/100kHz	≤4nW/100kHz (-54dBm), (Cf±1MHz : 2.5μW/100kHz)	
		710~1000MHz	746.648	-70.682 dBm/100kHz	0.00009μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - 1MHz	549.000	-61.425 dBm/100kHz	0.001μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - OBW x 2.5 kHz	549.712	-33.736 dBm/100kHz	0.423μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + OBW x 2.5kHz	550.288	-30.810 dBm/100kHz	0.830μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + 1MHz	551.000	-61.044 dBm/100kHz	0.001μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		1~4GHz	2426.1	-43.613 dBm/MHz	0.04μW/MHz	≤2.5μW/MHz(-26dBm)	

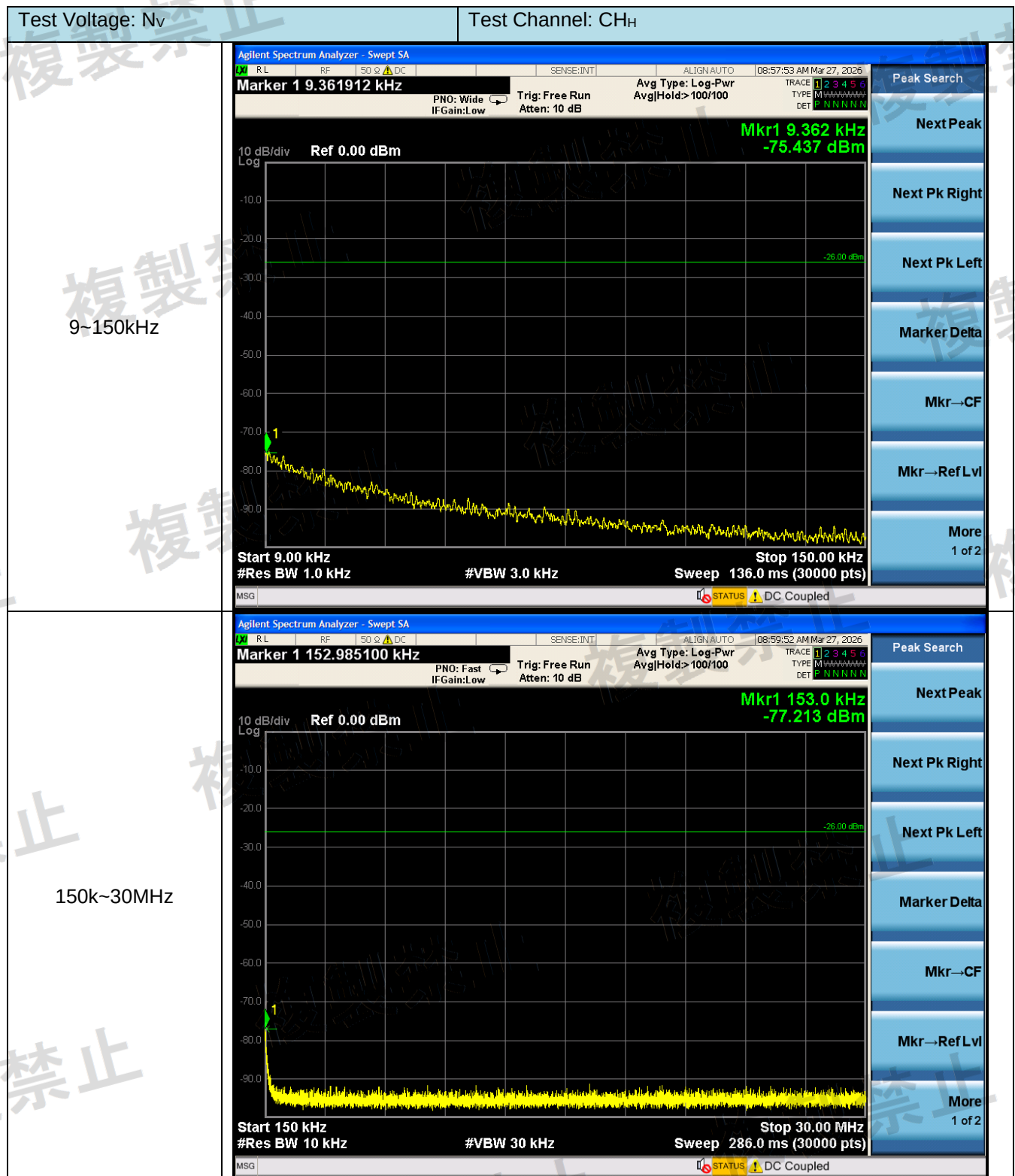


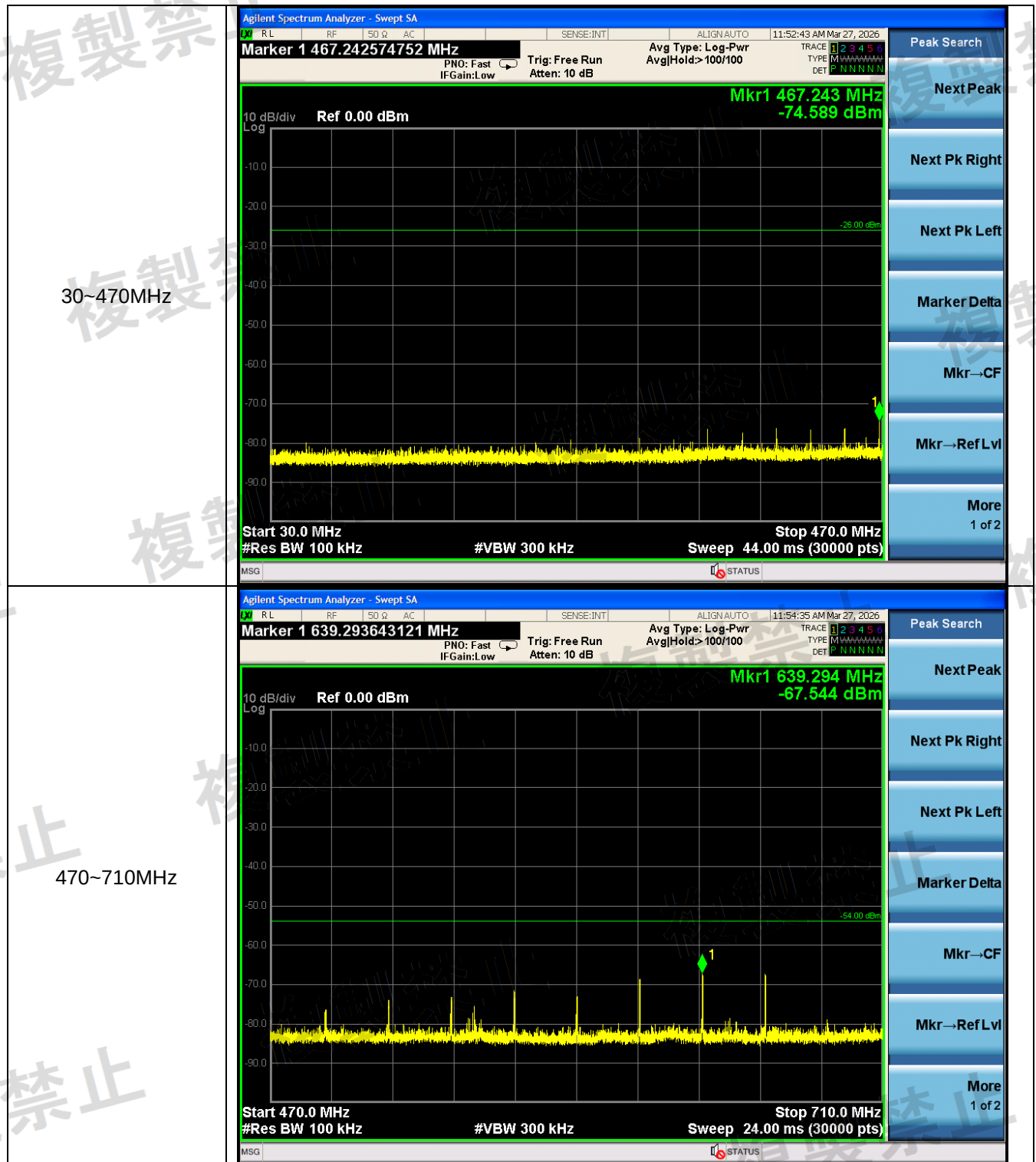


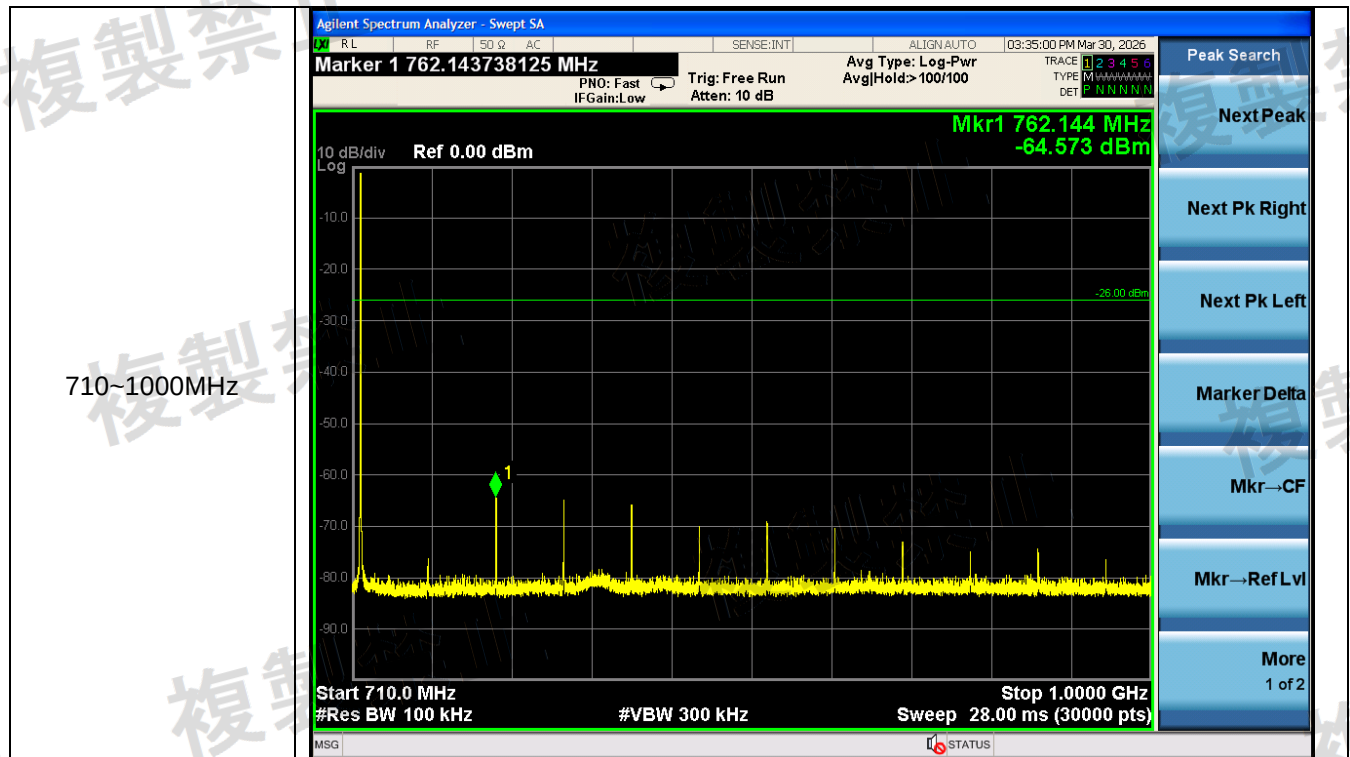




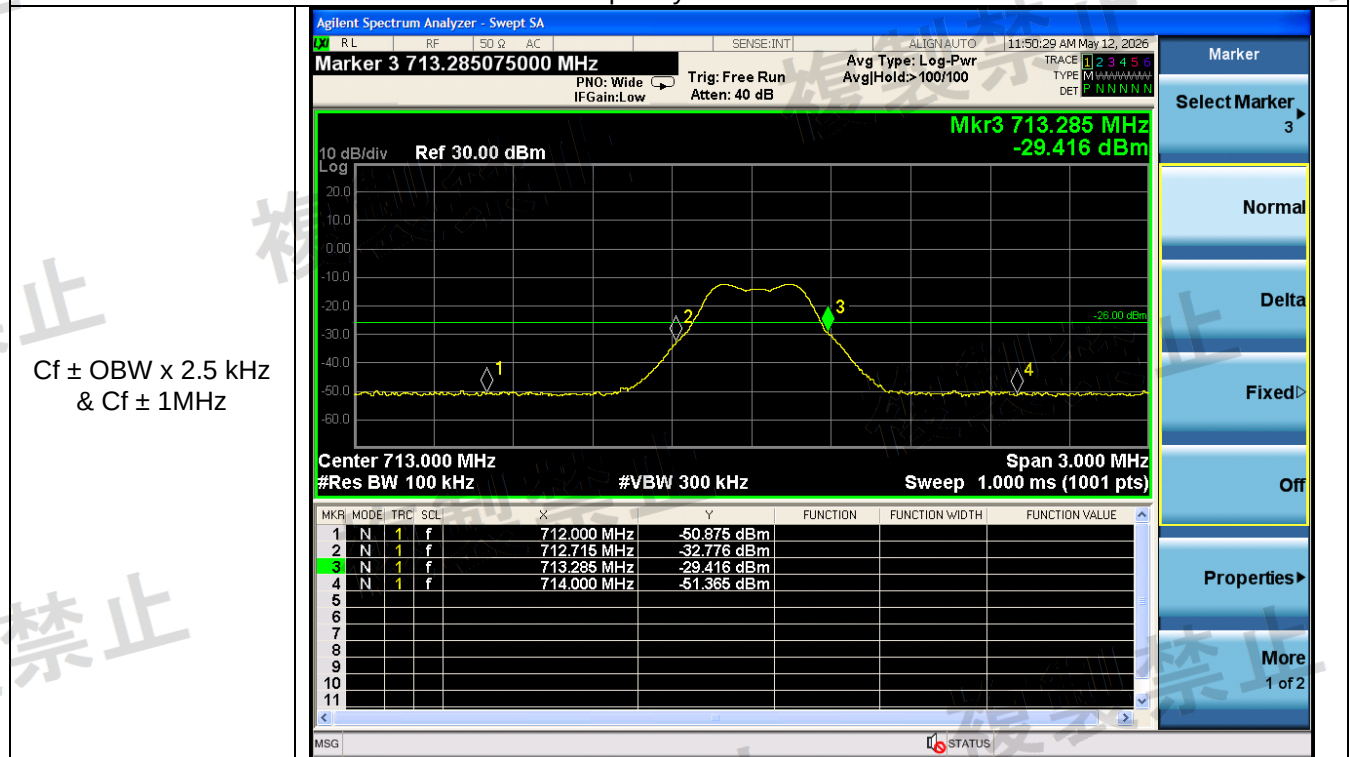
Test voltage	Test Channel	Frequency Range	Maximum frequency (MHz)	Measurement Level	Measurement Level	Limit	Result
Nv	CH _M	9~150kHz	0.011284	-74.977 dBm/1kHz	0.00003μW/1kHz	≤2.5μW/1kHz (-26dBm)	Pass
		150k~30MHz	0.15	-76.332 dBm/10kHz	0.00002μW/10kHz	≤2.5μW/10kHz (-26dBm)	
		30~470MHz	434.901	-71.584 dBm/100kHz	0.00007μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		470~710MHz	631.525	-62.749 dBm/100kHz	0.5nW/100kHz	≤4nW/100kHz (-54dBm), (Cf±1MHz : 2.5μW/100kHz)	
		710~1000MHz	729.779	-65.543 dBm/100kHz	0.0003μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - 1MHz	630.500	-60.555 dBm/100kHz	0.001μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - OBW x 2.5 kHz	631.220	-32.831 dBm/100kHz	0.521μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + OBW x 2.5 kHz	631.778	-29.539 dBm/100kHz	1.112μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + 1MHz	632.500	-61.426 dBm/100kHz	0.001μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		1~4GHz	3181.2	-67.095 dBm/MHz	0.0002μW/MHz	≤2.5μW/MHz (-26dBm)	

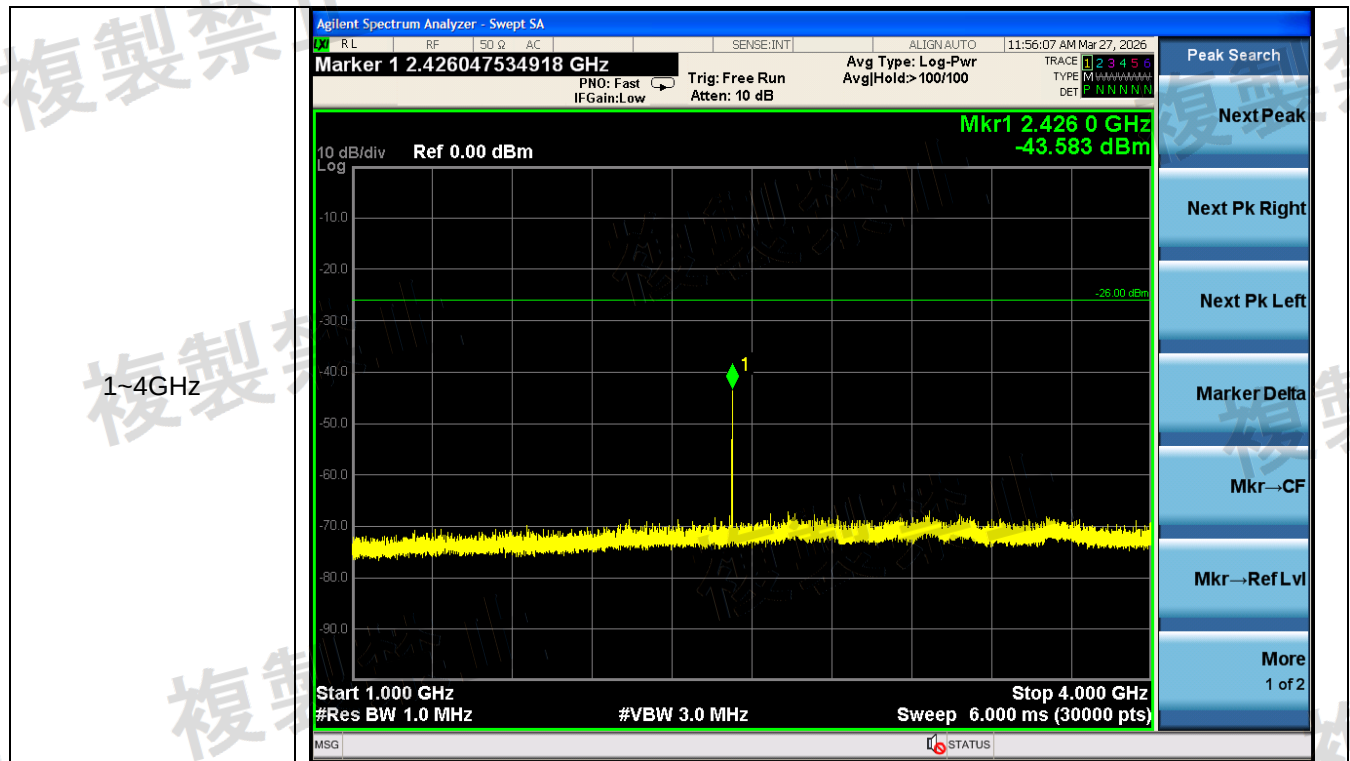






Note: Emission exceeded limit is fundamental frequency emission

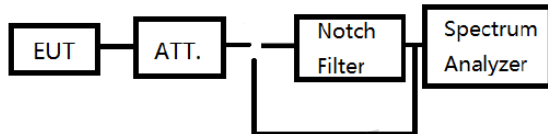




Test voltage	Test Channel	Frequency Range	Maximum frequency (MHz)	Measurement Level	Measurement Level	Limit	Result
Nv	CH _H	9~150kHz	0.009362	-75.437 dBm/1kHz	0.00004μW/1kHz	≤2.5μW/1kHz (-26dBm)	Pass
		150k~30MHz	0.153	-77.213 dBm/10kHz	0.00002μW/10kHz	≤2.5μW/10kHz (-26dBm)	
		30~470MHz	467.243	-74.589 dBm/100kHz	0.0003μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		470~710MHz	639.294	-67.544 dBm/100kHz	0.2nW/100kHz	≤4nW/100kHz (-54dBm), (Cf±1MHz : 2.5μW/100kHz)	
		710~1000MHz	762.144	-64.573 dBm/100kHz	0.0003μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - 1MHz	712.000	-50.875 dBm/100kHz	0.008μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf - OBW x 2.5 kHz	712.715	-32.776 dBm/100kHz	0.528μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + OBW x 2.5 kHz	713.285	-29.416 dBm/100kHz	1.144μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		Cf + 1MHz	714.000	-51.365 dBm/100kHz	0.007μW/100kHz	≤2.5μW/100kHz (-26dBm)	
		1~4GHz	2426.0	-43.583 dBm/MHz	0.04μW/MHz	≤2.5μW/MHz (-26dBm)	

5.6. Adjacent channel Leakage Power

LIMIT
≤40dBc



TEST CONDITION

Test diffusion code and modulate with standard coding test signal

TEST PROCEDURE

Decleared bandwithh	Spacing from Cent Frequency	Adjacent channel width
≤288kHz	500kHz	288kHz
(288kHz,600kHz)	800kHz	600kHz

Set to adjacent channel mode Cent Frequency: test channel,
Sweep time=Auto, Detector mode=Positive peak
Sweep time=Auto, Span=enough to cover the adjacent channel

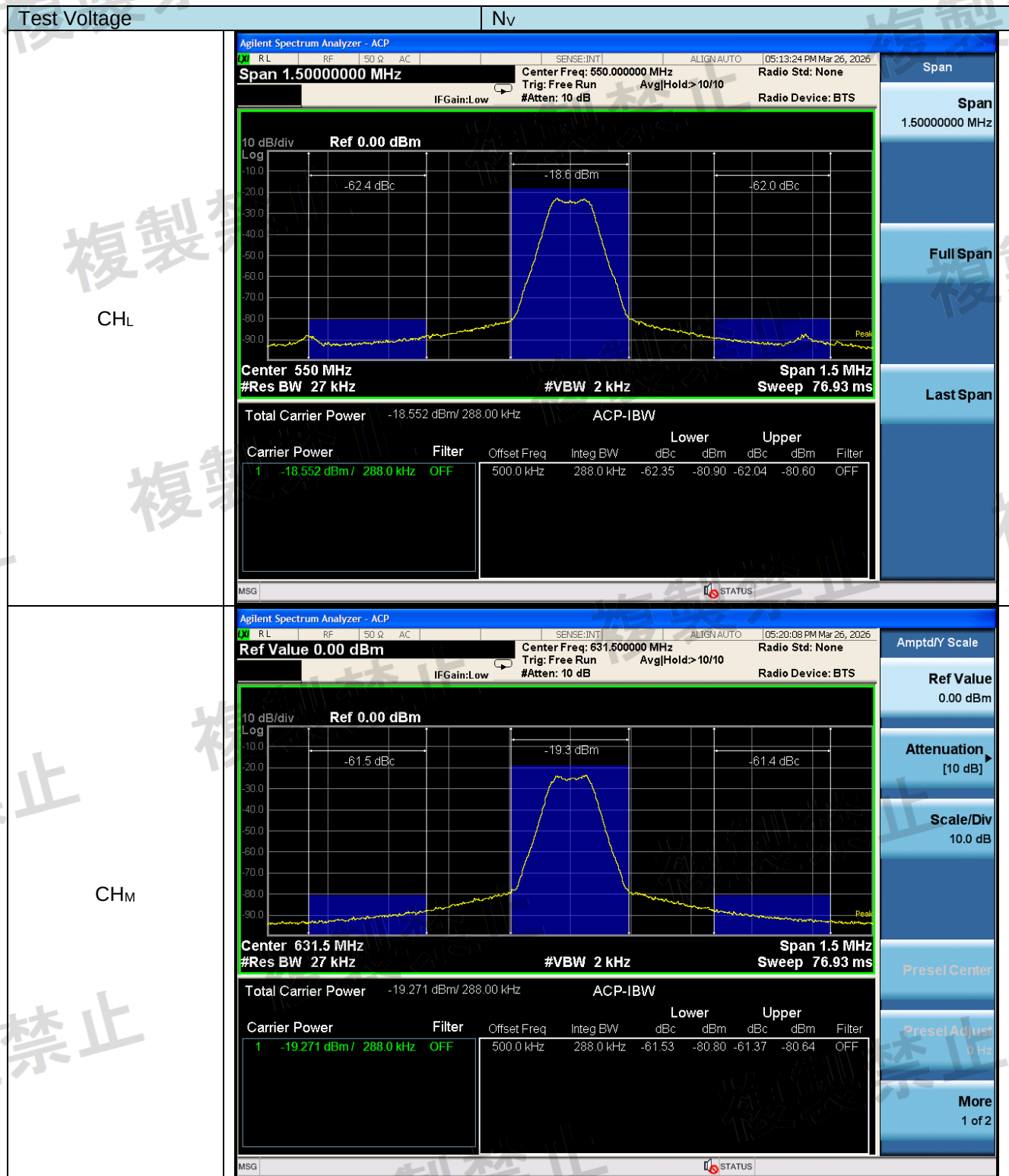
TEST RESULTS

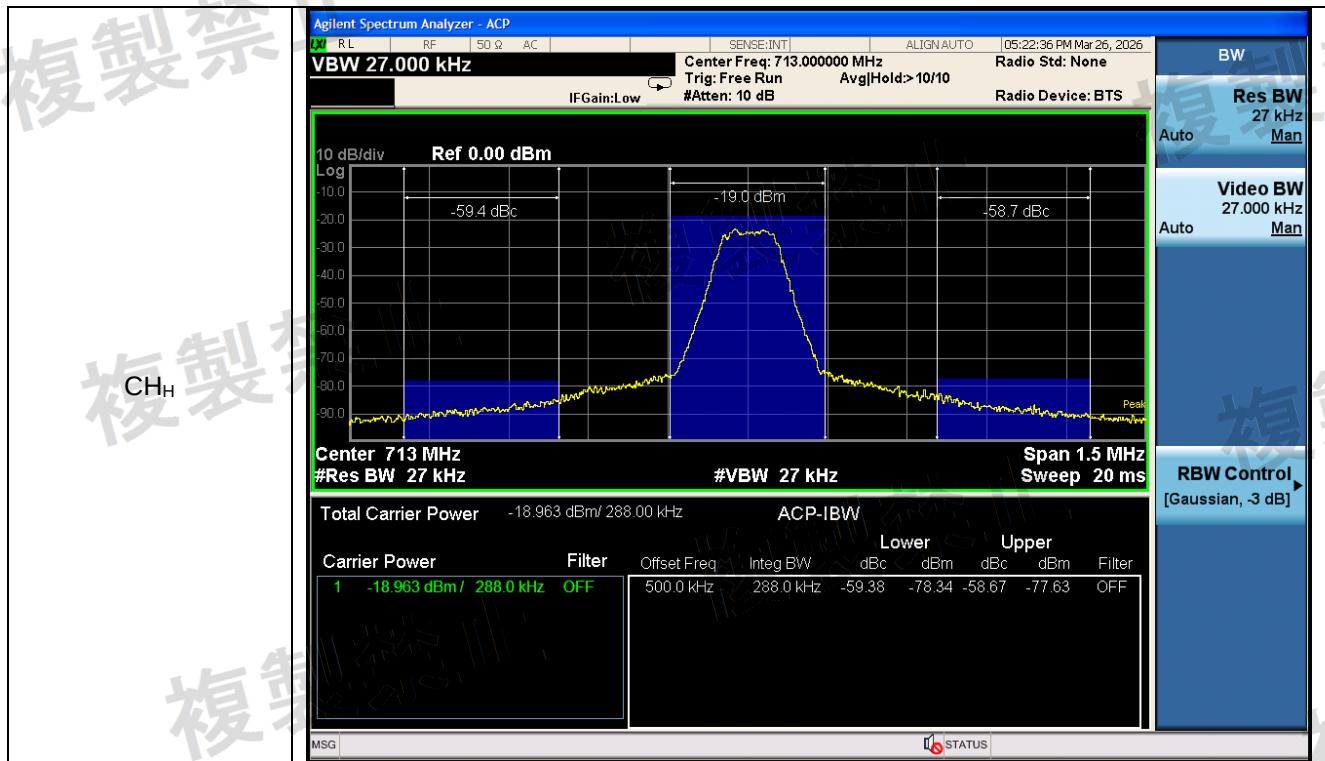
☒ Passed ☐ Not Applicable

Please refer to the below test data:

Test voltage	Test Channel	Rating Frequency (MHz)	Measured Value (dBc)		Limit (dBc)	Result
			Lower	Upper		
Nv	CH _L	550	-62.35	-62.04	≤-40	Pass
	CH _M	631.5	-61.53	-61.37		
	CH _H	713	-59.38	-58.67		

Test plot as follows:





5.7. Vibration Test

This test determines the ability of equipment to withstand vibration without resulting in mechanical weakness or degradation in performance.

The EUT, complete with any shock and vibration absorbers with which it is provided, shall be clamped to the vibration table by its normal means of support and in its normal attitude. Provision may be made to reduce or nullify any adverse effect on equipment performance which could be caused by the presence of an electromagnetic field due to the vibration unit.

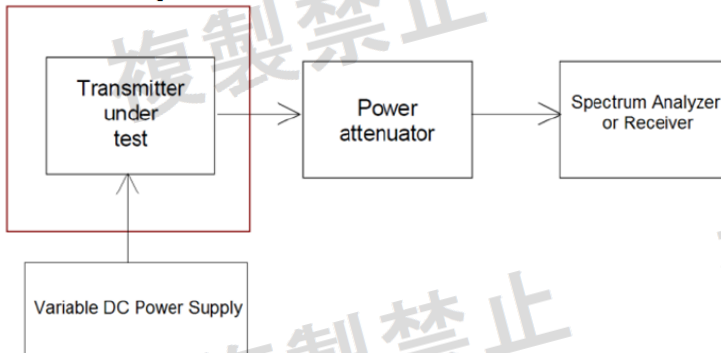
The equipment shall meet the Frequency Error. There shall be no harmful deterioration of the equipment visible.

LIMIT

Frequency Band(MHz)	Frequency Tolerance (ppm)
470 - 714	±20
1240 - 1260	±20

TEST CONFIGURATION

Vibration testing instruments



TEST CONDITION

Continuously transmitting without modulation

TEST PROCEDURE

- (1) The test equipment is fixed to the vibration plate of the vibration testing machine using a mounting jig or similar.
- (2) Vibration is applied to the test equipment using the vibration testing machine. However, the amplitude, frequency, and direction of the vibration applied to the test equipment must comply with the following conditions, and the order in which the vibration conditions are set may be arbitrary.
 - (a) Vibrations with a total amplitude of 3 mm and frequencies ranging from the lowest settable frequency (300 vibrations per minute or less; hereafter referred to as the "minimum frequency") to 500 vibrations per minute shall be applied in the up-down, left-right, and front-back directions for 15 minutes each. In this case, the applied vibrations shall be swept in the following order: from the minimum frequency to 500 vibrations per minute, from 500 vibrations per minute to the minimum frequency, and from the minimum frequency to 500 vibrations per minute.
 - (b) Vibrations with a total amplitude of 1 mm and frequencies ranging from 500 to 1,800 vibrations per minute shall be applied in the up-down, left-right, and front-back directions for 15 minutes each. In this case, the applied vibration frequency shall be swept from 500 bpm to 1,800 bpm, from 1,800 bpm to 500 bpm, and from 500 bpm to 1,800 bpm in that order.
- (3) After applying the vibration specified in (2), apply the power supply voltage specified in Section 1, 2(2) to operate the test equipment.

(4) In accordance with Section 4, measure the frequency of the test equipment using a frequency counter or spectrum analyzer. 3. Other

This test item shall not be performed if the construction specifications specify that the test equipment will be fixed to a non-moving, non-vibrating object.

TEST RESULTS

☒ Passed ☐ Not Applicable

Please refer to the below test data:

1mm vibration test:

Test voltage	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
N _v	CH _L	550	550.001	1.82	±20.00	Pass
	CH _M	631.5	631.501	1.58		
	CH _H	713	713.001	1.40		

3mm vibration test:

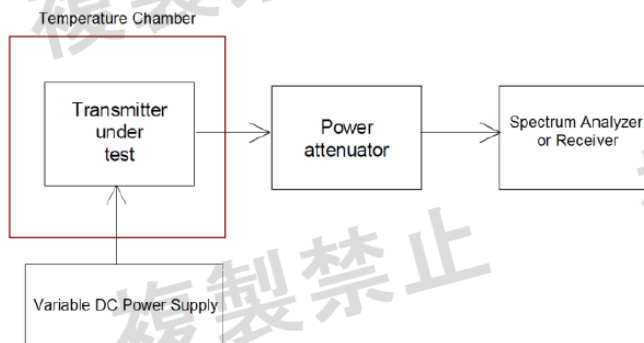
Test voltage	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
N _v	CH _L	550	550.001	1.82	±20.00	Pass
	CH _M	631.5	631.501	1.58		
	CH _H	713	713.001	1.40		

5.8. Temperature and Damp heat test

LIMIT

Frequency Band(MHz)	Frequency Tolerance (ppm)
470 - 714	±20
1240 - 1260	±20

TEST CONFIGURATION



TEST CONDITION

Continuously transmitting without modulation

TEST PROCEDURE

(1) Low-Temperature Test

A. Place the test equipment in a temperature and humidity test chamber, and set the temperature inside the chamber to a low temperature (0°C, -10°C, or -20°C, whichever is the lowest within the test equipment's specifications). B. Leave the test equipment in this state for one hour.

C. After the leave-in time specified in B has elapsed, operate the test equipment by applying the power supply voltage specified in Section 1.2(2) inside the temperature and humidity test chamber.

D. Measure the frequency of the test equipment using a frequency counter or spectrum analyzer in accordance with Section 4.

(2) High-Temperature Test

A. Place the equipment in a temperature and humidity test chamber. While in this state, set the temperature inside the chamber to a high temperature (40°C, 50°C, or 60°C, whichever is the highest within the specifications of the test equipment) and the humidity to normal humidity. B. Leave the equipment in this state for one hour.

C. After the leaving time specified in B has elapsed, apply the power supply voltage specified in Section 1.2(2) to operate the test equipment in the temperature and humidity test chamber.

D. Measure the frequency of the test equipment using a frequency counter or spectrum analyzer in accordance with Section 4.

(3) Humidity Test

A. Place the equipment in a temperature and humidity test chamber. While in this state, set the temperature inside the temperature and humidity test chamber to 35°C and the humidity to 95% relative humidity or the maximum humidity specified in the test equipment's specifications. B. Leave the equipment in this state for four hours.

C. After the leaving time specified in B has elapsed, return the temperature and humidity test chamber to normal temperature and humidity, confirm that no condensation has formed, and then apply the power supply voltage specified in Section 1.2(2) to operate the test equipment.

(d) In accordance with paragraph 4, measure the frequency of the test equipment using a frequency counter or spectrum analyzer.

TEST RESULTS

☒ Passed ☐ Not Applicable

Please refer to the below test data:

Low-Temperature Test:

Test voltage	Test Temperature(°C)	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
Nv	-20	CH _L	550	550.001	1.82	±20.00	Pass
		CH _M	631.5	631.501	1.58		
		CH _H	713	713.002	2.81		

High-Temperature:

Test voltage	Test Temperature(°C)	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
Nv	60	CH _L	550	550.001	1.82	±20.00	Pass
		CH _M	631.5	631.502	3.17		
		CH _H	713	713.002	2.81		

Humidity Test:

Test voltage	Test Temperature(°C)	Humidity(%)	Test Channel	Rating Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)	Limit (ppm)	Result
Nv	35	95	CH _L	550	550.001	1.82	±20.00	Pass
			CH _M	631.5	631.502	3.17		
			CH _H	713	713.002	2.81		

6. Test Setup Photos of the EUT



7. External and Internal Photos of the EUT

Please refer to WTH26H03056177W001 report.

Statement

1. This report is considered invalid without approved signature and special seal;
2. The Applicant name and Address, the sample(s) and sample information was/were provided by the applicant who should be responsible for the authenticity which HCT hasn't verified;
3. The result(s) shown in this report refer(s) only to the sample(s) tested;
4. The “*” in CNAS logo report means that the test item(s) was (were) currently not applying for CNAS accreditation
5. Without written approval of HCT, this report can't be reproduced except in full.
6. For any claim of the report, just refer to the testing unit in 15 days, in case it is not in the above limited time, the claim shall be dismissed.
7. If not explicitly stated otherwise in the standard, the test is passed if the measured value is equal to or below(above) the limit line, regardless of the measurement uncertainty. If the measured value is above(below) the limit line, the test is not passed.
8. Measurement uncertainties are calculated for all instruments and instrument set-ups given in this report. Calculations are based on the principles given in the standard EA-4/02(Dec.1999), IEC Guide 115:2007,CNAS-GL007:2020, CNAS-CL01-G003:2021and other relevant internal HCT-procedures. Further information about measurement uncertainties will be given on request.
9. All instruments used in the tests given in this test report are calibrated and traceable to national or international standards. Further information about traceability will be given on request.

-----End of Report-----